



中国认可
国际互认
检测
TESTING
CNAS L6478



TEST REPORT

Reference No...... : WTF24F11263756W003
Applicant..... : Mid Ocean Brands B.V.
Address..... : 7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Manufacturer : 111033
Address..... : ---
Product Name..... : A4 folder wireless power bank
Model No...... : MO2495
Test specification..... : ETSI EN 301 489-1 V2.2.3 (2019-11)
ETSI EN 301 489-3 V2.3.2 (2023-01)
Date of Receipt sample : 2024-12-17
Date of Test : 2024-12-17 to 2024-12-18
Date of Issue..... : 2024-12-27
Test Report Form No. : WEW-301489A-01B
Test Result..... : **Pass**

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

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1 Test Summary

Emission				
Test	Test Requirement	Test Method	Class / Severity	Result
Conducted Emissions	ETSI EN 301 489-3 V2.3.2	ETSI EN 301 489-1 V2.2.3 EN 55032	Table A.10 of EN 55032	Pass
Radiation Emission		ETSI EN 301 489-1 V2.2.3 EN 55032	Table A.4 and Table A.5 of EN 55032	Pass
Immunity				
Test	Test Requirement	Test Method	Class / Severity	Result
Electrostatic Discharge (ESD)	ETSI EN 301 489-3 V2.3.2	ETSI EN 301 489-1 V2.2.3 EN 61000-4-2	±2/±4 kV Contact ±2/±4/±8 kV Air	Pass
Radio frequency electromagnetic field (80 MHz to 6 000MHz)		ETSI EN 301 489-1 V2.2.3 EN 61000-4-3	3V/m, 80%, 1kHz, Amp. Mod.	Pass
Fast Transients Common Mode (EFT)		ETSI EN 301 489-1 V2.2.3 EN 61000-4-4	AC±0.5/1.0kV	Pass
Surge		ETSI EN 301 489-1 V2.2.3 EN 61000-4-5	±1kV D.M.† ±2kV C.M.‡	Pass
RF common mode 0,15 MHz to 80 MHz (CS)		ETSI EN 301 489-1 V2.2.3 EN 61000-4-6	3Vrms(emf), 80%, 1kHz Amp. Mod.	Pass
Voltage Dips and Interruptions		ETSI EN 301 489-1 V2.2.3 EN 61000-4-11	0 % UT* for 0.5per 0 % UT* for 1per 70 % UT* for 25per 0 % UT* for 250per	Pass

Remark:

Pass	Test item meets the requirement
Fail	Test item does not meet the requirement
N/A	Test case does not apply to the test object
A.M	Amplitude Modulation
†	Differential Mode
‡	Common Mode
*	U _T is the nominal supply voltage



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3 General Information

3.1 General Description of E.U.T.

Product Name : A4 folder wireless power bank

Model No. : MO2495

Remark : ---

3.2 Details of E.U.T.

Technical Data : Type-C Input: DC 5V/3A, DC 9V/2A, DC 12V/1.5A
Type-C Output: DC 5V/3A, DC 9V/2A, DC 12V/1.5A
USB-A Output: DC 5V/3A, DC 9V/2A
Wireless output power: 15W Max.
Battery capacity: 3.7V, 5000mAh, 18.5Wh

3.3 Description of Support Units

The EUT has been tested as an independent unit. MO2495 is the test sample. The DV and RE tests were performed in the condition of AC 240V/50Hz input. The other tests were performed in the condition of AC 230V/50Hz input.

3.4 Standards Applicable for Testing

The tests were performed according to following standards:

ETSI EN 301 489-1 V2.2.3 (2019-11)	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 1: Common technical requirements; Harmonised Standard for ElectroMagnetic Compatibility
ETSI EN 301 489-3 V2.3.2 (2023-01)	ElectroMagnetic Compatibility (EMC) standard for radio equipment and services; Part 3: Specific conditions for Short Range Devices (SRD) operating on frequencies between 9 kHz and 246 GHz; Harmonised Standard for ElectroMagnetic Compatibility

3.5 Test Facility

The test facility has a test site registered with the following organizations:

- **ISED – Registration No.: 21895**

Waltek Testing Group (Foshan) Co., Ltd. has been registered and fully described in a report filed with the Innovation, Science and Economic Development Canada (ISED). The acceptance letter from the ISED is maintained in our files. Registration ISED number: 21895, March 12, 2019

- **FCC – Registration No.: 820106**

Waltek Testing Group (Foshan) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 820106, August 16, 2018

- **NVLAP – Lab Code: 600191-0**

Waltek Testing Group (Foshan) Co., Ltd. EMC Laboratory is accredited by the National Voluntary Laboratory Accreditation Program (NVLAP/NIST). NVLAP Code: 600191-0.

This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.



3.6 Subcontracted

Whether parts of tests for the product have been subcontracted to other labs:

☐ Yes ☒ No

If Yes, list the related test items and lab information:

Test items: ---

Lab information:---

3.7 Abnormalities from Standard Conditions

None.

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4 Equipment Used during Test

4.1 Equipment List

☐ Mains Terminal Disturbance Voltage 1#(Conducted Emission)						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	EMI Test Receiver	R&S	ESR3	102423	2024-01-05	2025-01-04
2.	LISN	R&S	ENV216	101343	2024-01-05	2025-01-04
3.	Cable	HUBER+SUHNER	CBL2-NN-6M	223NN624	2024-01-04	2025-01-03
4.	Switch	CD	RSU-A4 18G	RSUA4008	2024-01-04	2025-01-03
☒ Mains Terminal Disturbance Voltage 2#(Conducted Emission)						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	EMI Test Receiver	R&S	ESCI	101178	2024-01-06	2025-01-05
2.	LISN	R&S	ENV216	101215	2024-01-05	2025-01-04
3.	Cable	HUBER+SUHNER	CBL2-NN-6M	6102701	2024-01-04	2025-01-03
4.	Switch	ESE	RSU/M2	---	2024-01-04	2025-01-03
☐ Mains Terminal Disturbance Voltage 3#(Conducted Emission)						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	EMI Test Receiver	R&S	ESR3	102842	2024-01-05	2025-01-04
2.	LISN	R&S	ENV216	101542	2024-01-05	2025-01-04
3.	Cable	YIHENG	LMR195UF-NMNM-2.5	---	2024-01-04	2025-01-03
4.	Manual RF Switch	YIHENG	SW-2	RSU0402	2024-01-04	2025-01-03
☐ Radiated Emission (30MHz to 1GHz) 1#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	3m Semi-anechoic Chamber	CHANGCHUANG	9m×6m×6m	-	2024-01-06	2025-01-05
2.	EMI Test Receiver	R&S	ESR7	101566	2024-01-06	2025-01-05
3.	Trilog Broadband Antenna	SCHWARZBECK	VULB 9162	9162-117	2024-01-06	2025-01-05
4.	Coaxial Cable (below 1GHz)	H+S	CBL3-NN-12+3m	214NN320	2024-01-06	2025-01-05
☒ Radiated Emission (30MHz to 1GHz) 2#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	3m Semi-anechoic Chamber	YIHENG	9m×6m×6m	YH2021071801	2024-01-06	2025-01-05
2.	EMI Test Receiver	R&S	ESR7	102454	2024-01-06	2025-01-05
3.	Trilog Broadband Antenna	SCHWARZBECK	VULB 9163	01418	2024-02-22	2025-02-21
4.	Coaxial Cable (below 1GHz)	Times-Microwave Systems	LMR240UF-NMSM-7.5	-	2024-01-06	2025-01-05



☐ Radiated Emission (1GHz to 6GHz) 1#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	3m Semi-anechoic Chamber	CHANGCHUANG	9m×6m×6m	-	2024-01-05	2025-01-04
2.	EMI Test Receiver	R&S	ESR7	101566	2024-01-06	2025-01-05
3.	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9120 D	01561	2024-01-05	2025-01-04
4.	Coaxial Cable (above 1GHz)	Times-Microwave	CBL5-NN	-	2024-01-04	2025-01-03
5.	Preamplifier	Lunar E M	LNA1G18-40	20160501002	2024-01-04	2025-01-03
☐ Radiated Emission (1GHz to 6GHz) 2#						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	3m Semi-anechoic Chamber	YIHENG	9m×6m×6m	YH2021071801	2024-01-06	2025-01-05
2.	EMI Test Receiver	R&S	ESR7	102454	2024-01-06	2025-01-05
3.	Broad-band Horn Antenna	SCHWARZBECK	BBHA9120D	02465	2024-01-05	2025-01-04
4.	Coaxial Cable (above 1GHz)	Times-Microwave Systems	SFT205-NMSM-7	-	2024-01-06	2025-01-05
5.	Preamplifier	Tonscend	TAP0118045	AP21J806168	2024-01-05	2025-01-04
☒ ESD						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	ESD Simulator	TESEQ	NSG437	521	2024-01-03	2025-01-02
☒ EFT & Voltage Dips and Interruptions						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	EMS test system	TESEQ	NSG3040	1858	2024-01-06	2025-01-05
☒ Surge						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	Surge Simulator	TESEQ	NSG3060	1395	2024-01-05	2025-01-04
☒ Injected Currents						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	Conducted Immunity test system	TESEQ	NSG4070	45345	2024-01-05	2025-01-04
2.	CDN	TESEQ	CDN M016	31586	2024-01-05	2025-01-04
3.	6dB Attenuator	TESEQ	ATN6075	32122	2024-01-05	2025-01-04
☒ Radio-frequency electromagnetic fields						
Item	Equipment	Manufacturer	Model No.	Serial No.	Cal Date	Due Date
1.	RF Power Amplifier	OPHIR	5225R	1051/1712	2024-01-05	2025-01-04
2.	RF Power Amplifier	OPHIR	5293RE	1051/171	2024-01-05	2025-01-04
3.	Stacked double logarithmic periodic antenna	SCHWARZBECK	STLP9128E-SPECIAL	142	2024-01-05	2025-01-04



4.	Stacked double logarithmic periodic antenna	SCHWARZBECK	STLP 9149	476	2024-01-05	2025-01-04
5.	Analog signal generator	RS	SMB100A	105566	2024-01-04	2025-01-03
6.	Power meter	RS	NRP6A	101133	2024-01-05	2025-01-04
7.	Power meter	RS	NRP6A	101134	2024-01-05	2025-01-04

☐: Not Used

☒: Used

4.2 Software List

Description	Manufacturer	Model	Version
EMI Test Software (Conducted Emission 1#)	FARATRONIC	EZ-EMC	EMEC-3A1
EMI Test Software (Conducted Emission 2#)	FARATRONIC	EZ-CON	FARAD-3A1.1+
EMI Test Software (Conducted Emission 3#)	FARATRONIC	EZ-EMC	EMC-CON 3A1.1+
EMI Test Software (Radiated Emission 1#)	FARATRONIC	EZ-EMC	RA-03A1-2
EMI Test Software (Radiated Emission 2#)	FARATRONIC	EZ-EMC	RA-03A1-2
Radiated Immunity Test Software	Chinese EMC	EMS	V1.0.0.0

4.3 Measurement Uncertainty

Test Item	Frequency Range	Uncertainty	Note
Conducted Emission	150kHz~30MHz	±2.6dB	(1)
Radiated Emission	30MHz~1GHz	±4.5dB	(1)
Radiated Emission	1GHz~6GHz	±4.5dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.



4.4 Special Accessories and Auxiliary Equipment

Item	Equipment	Technical Data	Manufacturer	Model No.
1.	AC Adapter	Input: 100-240V~, 50/60Hz, 0.5A Output: 5Vdc, 2.5A/9Vdc, 2A/12Vdc, 1.5A	Xiaomi	MDY-08-EH

4.5 Decision Rule

Compliance or non-compliance with a disturbance limit shall be determined in the following manner.

If U_{LAB} is less than or equal to U_{cispr} , then

- Compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- Non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

If U_{LAB} is greater than U_{cispr} , then

- Compliance is deemed to occur if no measured disturbance level, increased by $(U_{LAB} - U_{cispr})$, exceeds the disturbance limit;
- Non-compliance is deemed to occur if any measured disturbance level, increased by $(U_{LAB} - U_{cispr})$, exceeds the disturbance limit.

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5 EMC Requirements for Emissions

5.1 Conducted Emission

Test Requirement	ETSI EN 301 489-3
Test Method	ETSI EN 301 489-1, EN 55032 Class B
Frequency Range	150kHz to 30MHz
Class/Severity	Class B/ Table A.10 of EN 55032
Ports	AC Mains
Detector	Peak for pre-scan (9kHz Resolution Bandwidth)

5.1.1 E.U.T. Operation

Operating Environment:

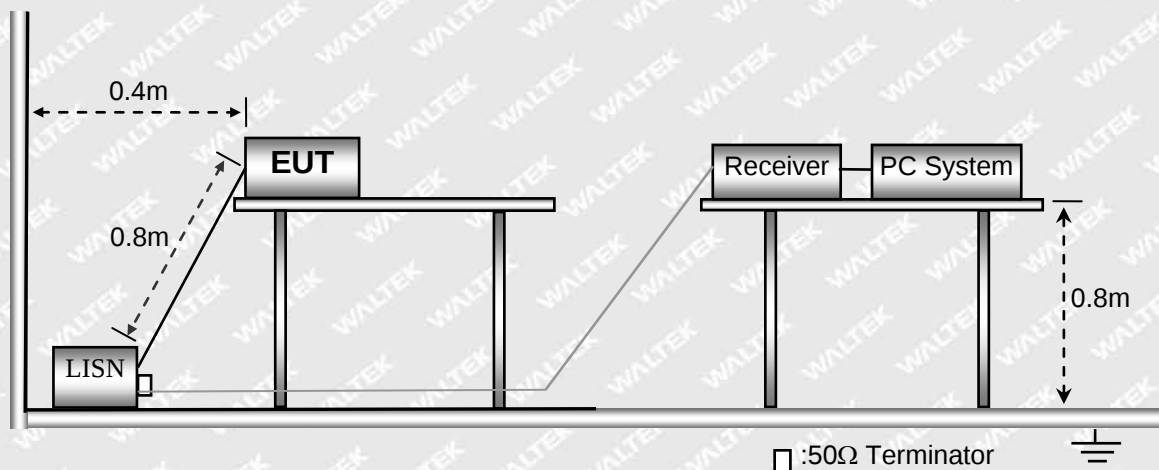
Temperature	20.8°C
Humidity	49.3%RH
Atmospheric Pressure	101.2kPa

EUT Operation:

Input Voltage	AC 240V/50Hz
Operating Mode	AC charging + wireless charging mode

5.1.2 Test Setup

The conducted emission tests were performed using the setup accordance with the EN 55032.





5.1.3 Corrected Amplitude & Margin Calculation

The Corrected factor is calculated by adding LISN VDF(Voltage Division Factor), Cable Loss and Transient Limiter Attenuation. The basic equation is as follows:

$$\text{Measurement} = \text{Reading Level} + \text{Correct Factor}$$

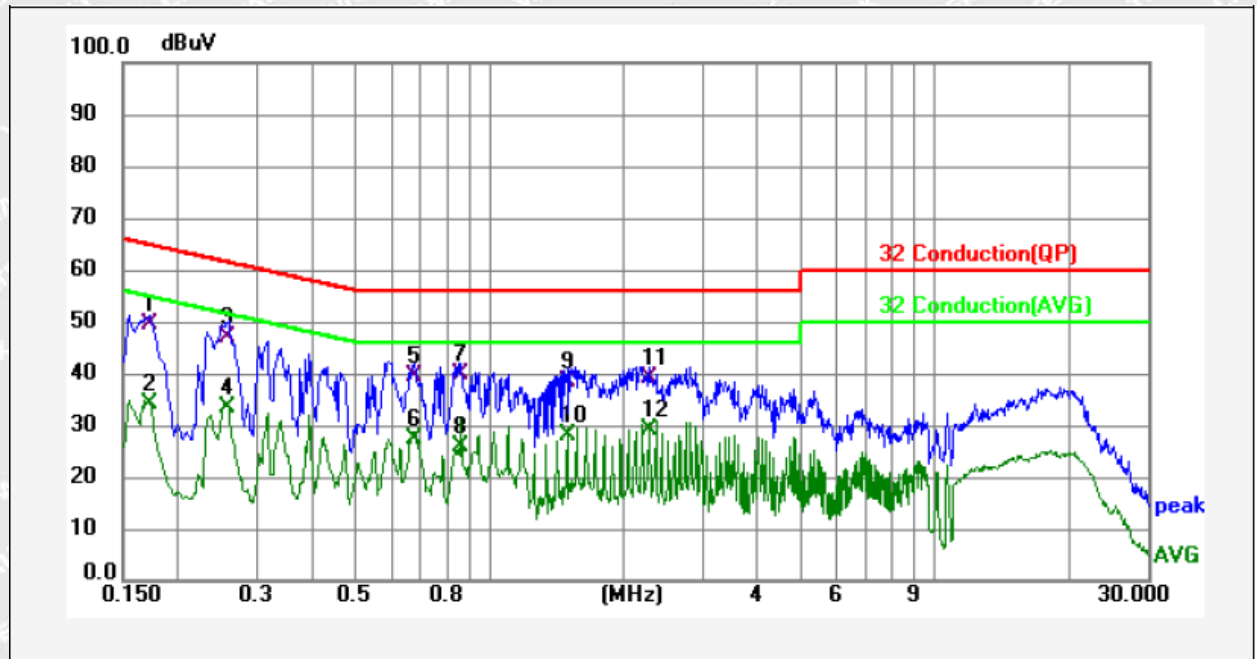
$$\text{Correct Factor} = \text{LISN VDF} + \text{Cable Loss}$$

The “Margin” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Measurement} - \text{Limit}$$

5.1.4 Test Result

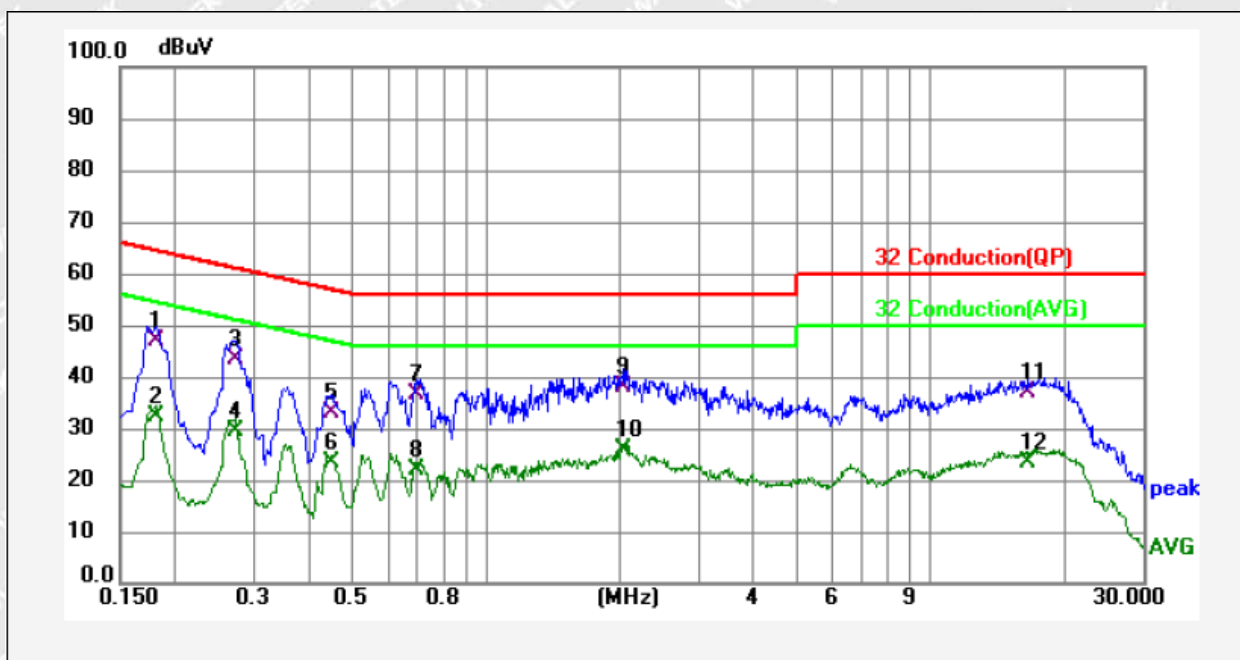
Live Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector	Remark
1	0.172	39.93	9.61	49.54	64.86	-15.32	QP	
2	0.172	24.39	9.61	34.00	54.86	-20.86	AVG	
3	0.258	37.35	9.61	46.96	61.50	-14.54	QP	
4	0.258	23.65	9.61	33.26	51.50	-18.24	AVG	
5	0.681	29.85	9.65	39.50	56.00	-16.50	QP	
6	0.681	17.72	9.65	27.37	46.00	-18.63	AVG	
7	0.866	30.33	9.67	40.00	56.00	-16.00	QP	
8	0.866	16.33	9.67	26.00	46.00	-20.00	AVG	
9	1.496	28.65	9.71	38.36	56.00	-17.64	QP	
10	1.496	18.29	9.71	28.00	46.00	-18.00	AVG	
11	2.283	29.23	9.77	39.00	56.00	-17.00	QP	
12	2.283	19.35	9.77	29.12	46.00	-16.88	AVG	



Neutral Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector	Remark
1	0.181	37.37	9.53	46.90	64.44	-17.54	QP	
2	0.181	22.89	9.53	32.42	54.44	-22.02	AVG	
3	0.272	33.82	9.54	43.36	61.06	-17.70	QP	
4	0.272	19.82	9.54	29.36	51.06	-21.70	AVG	
5	0.447	23.56	9.56	33.12	56.93	-23.81	QP	
6	0.447	14.00	9.56	23.56	46.93	-23.37	AVG	
7	0.695	27.11	9.58	36.69	56.00	-19.31	QP	
8	0.695	12.42	9.58	22.00	46.00	-24.00	AVG	
9	2.040	28.34	9.66	38.00	56.00	-18.00	QP	
10	2.040	16.34	9.66	26.00	46.00	-20.00	AVG	
11	16.651	26.76	10.24	37.00	60.00	-23.00	QP	
12	16.651	13.27	10.24	23.51	50.00	-26.49	AVG	



5.2 Radiated Emission

Test Requirement	ETSI EN 301 489-3
Test Method	ETSI EN 301 489-1, EN 55032, Class B
Frequency Range	30MHz to 1GHz
Class/Severity	Class B/ Table A.4 of EN 55032
Detector	Peak for pre-scan (120kHz Resolution Bandwidth Below 1GHz)

5.2.1 EUT Operation:

Operating Environment:

Temperature	23.6°C
Humidity	48.9%RH
Atmospheric Pressure	101.2kPa

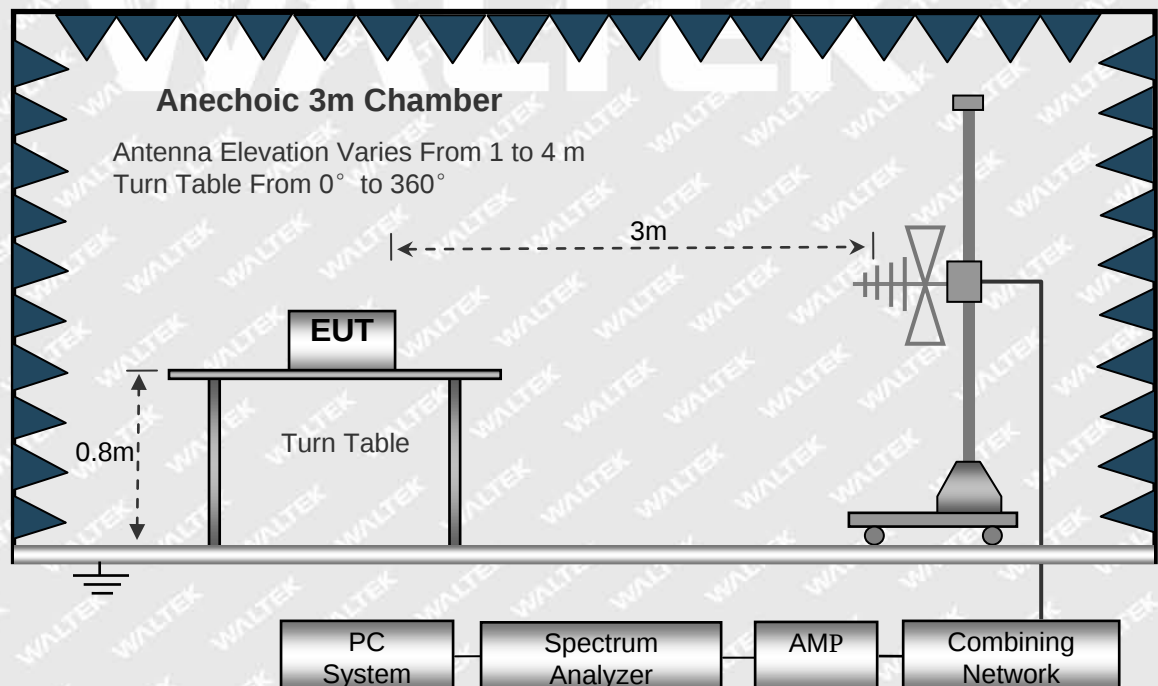
EUT Operation:

Input Voltage	AC 240V/50Hz
Operating Mode	AC charging + wireless charging mode

5.2.2 Test Setup

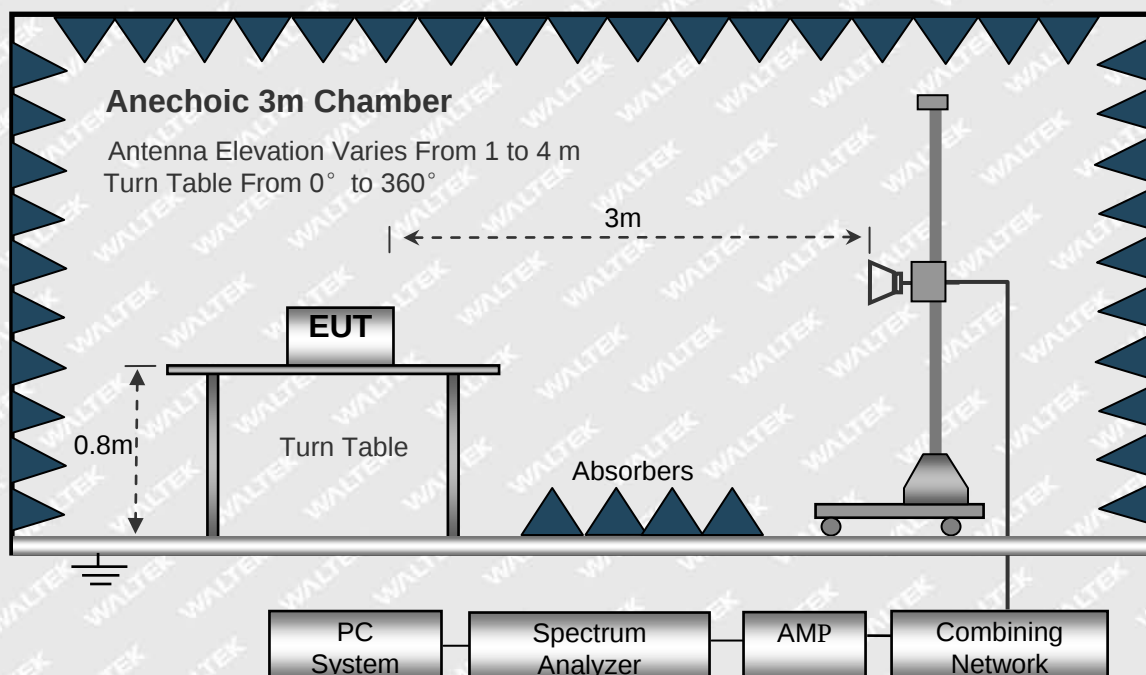
The radiated emission tests were performed using the setup accordance with the EN 55032.

Frequency Range: Below 1 GHz





Frequency Range: Above 1 GHz



5.2.3 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Corr. Factor}$$

$$\text{Corr. Factor} = \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the maximum limit.

The equation for margin calculation is as follows:

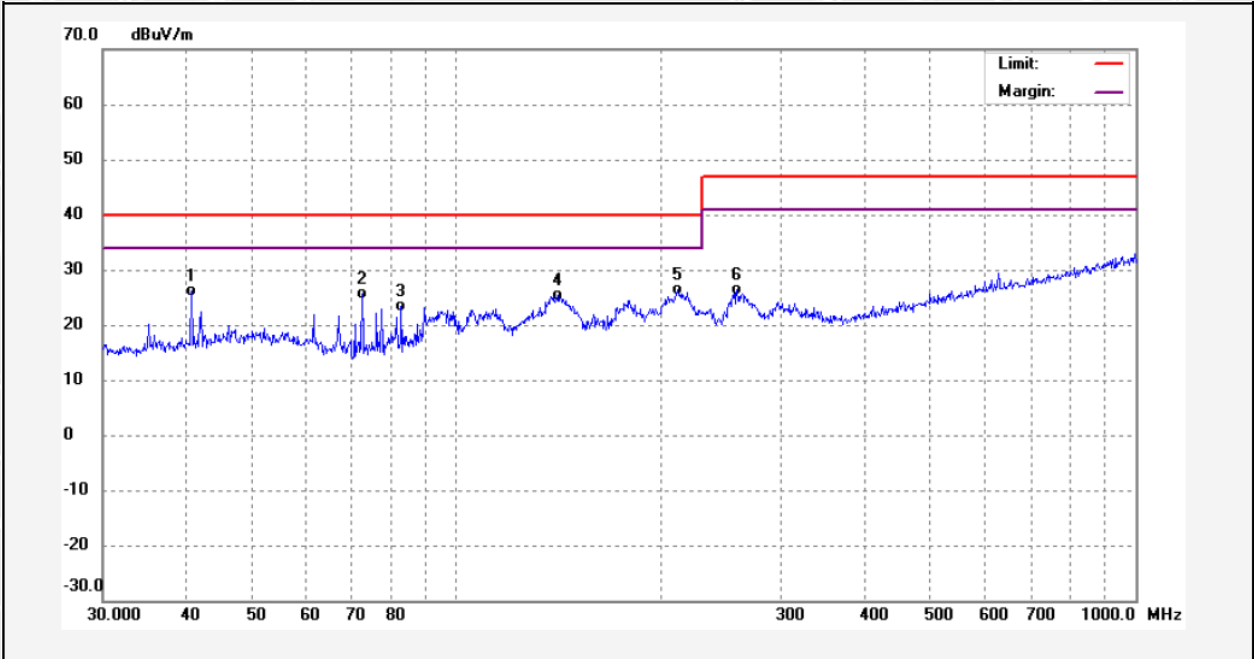
$$\text{Margin} = \text{Corr. Ampl.} - \text{Limit}$$



5.2.4 Test Result

Frequency Range: 30MHz ~ 1000MHz

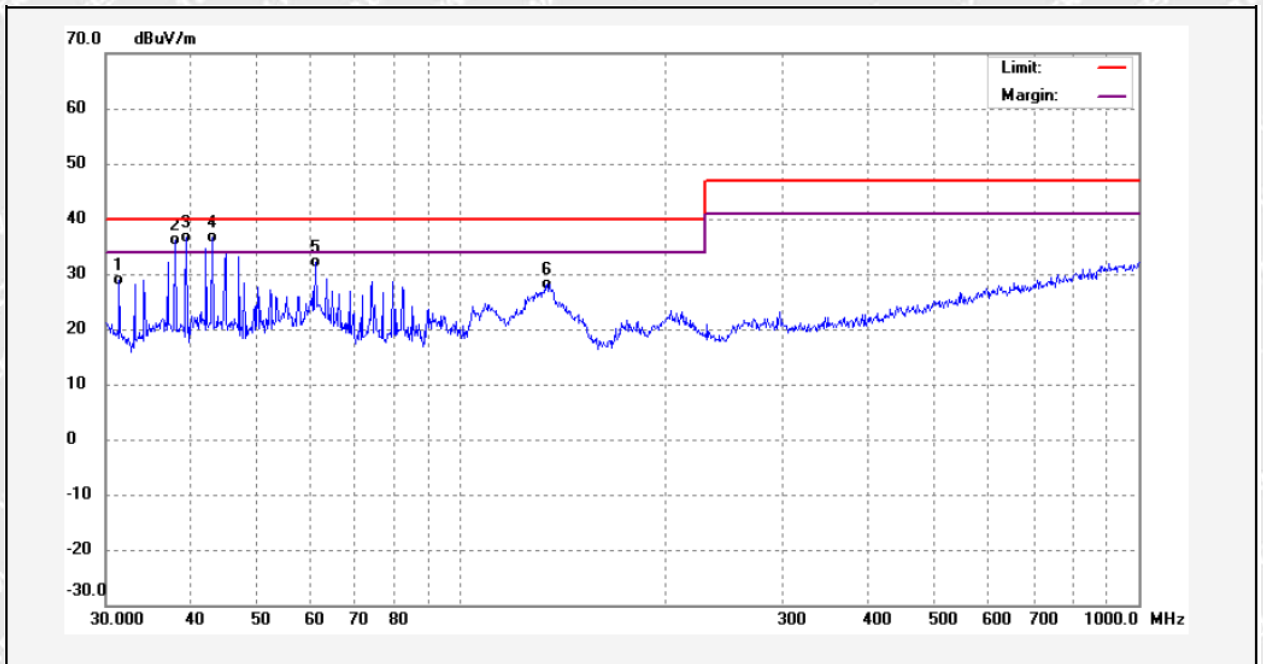
Antenna Polarization: Vertical



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Remark
1	40.6018	7.42	18.70	26.12	40.00	-13.88	QP	
2	72.4899	9.97	15.65	25.62	40.00	-14.38	QP	
3	82.7932	8.44	14.83	23.27	40.00	-16.73	QP	
4	141.1812	11.04	14.38	25.42	40.00	-14.58	QP	
5	212.2695	8.11	18.21	26.32	40.00	-13.68	QP	
6	258.6890	6.80	19.63	26.43	47.00	-20.57	QP	



Antenna Polarization: Horizontal



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Remark
1	31.4433	12.12	16.79	28.91	40.00	-11.09	QP	
2	37.9539	17.96	18.16	36.12	40.00	-3.88	QP	
3	39.4480	18.14	18.47	36.61	40.00	-3.39	QP	
4	43.1260	17.53	19.22	36.75	40.00	-3.25	QP	
5	61.1745	13.86	18.17	32.03	40.00	-7.97	QP	
6	134.1822	13.40	14.62	28.02	40.00	-11.98	QP	



6 EMC Requirement for Immunity

6.1 Performance Criteria

6.1.1 General performance criteria

The performance criteria are used to take a decision on whether a radio equipment passes or fails immunity tests.

For the purpose of the present document two categories of performance criteria apply:

- Performance criteria for continuous phenomena.
- Performance criteria for transient phenomena.

6.1.2 Performance criteria for continuous phenomena

During the test, the equipment shall:

- continue to operate as intended;
- not unintentionally transmit;
- not unintentionally change its operating state;
- not unintentionally change critical stored data.

6.1.3 Performance criteria for transient phenomena

For all ports and transient phenomena with the exception described below, the following applies:

- The application of the transient phenomena shall not result in a change of the mode of operation (e.g. unintended transmission) or the loss of critical stored data.
- After application of the transient phenomena, the equipment shall operate as intended.

For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:

- For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be otherwise restored. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.
- For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.



6.2 Electrostatic Discharge(ESD)

Test Requirement	: ETSI EN 301 489-3
Test Method	: ETSI EN 301 489-1, EN 61000-4-2
Discharge Impedance	: 330 Ω / 150 pF
Discharge Voltage	: Air Discharge: +/-2,4,8 KV Contact Discharge: +/-2,4 KV HCP & VCP: +/-2,4 KV
Polarity	: Positive & Negative
Discharge Repeat Times	: At Least 20 times at each test point
Discharge Mode	: Single Discharge
Discharge Period	: 1 second minimum

6.2.1 E.U.T. Operation

Operating Environment:

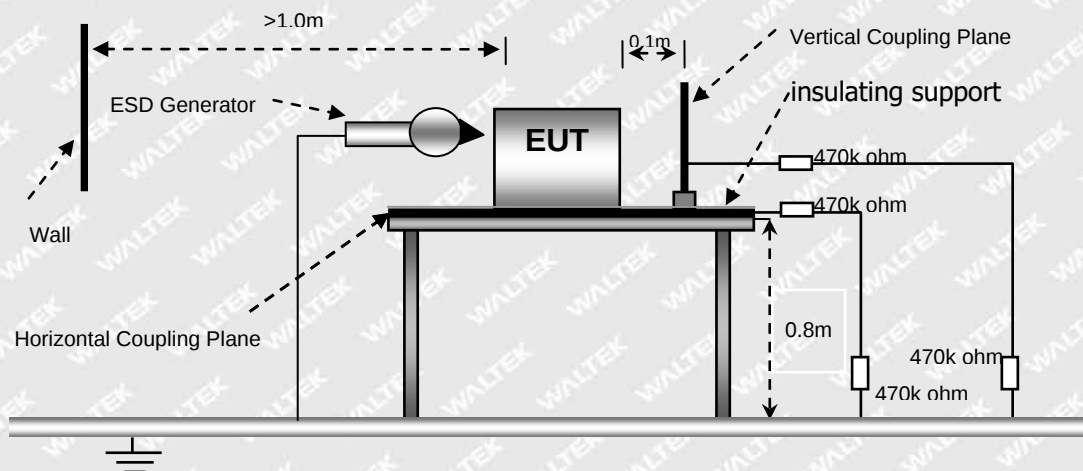
Temperature	: 22.4°C
Humidity	: 52.6%RH
Atmospheric Pressure	: 100.1kPa

EUT Operation:

Input Voltage	: AC 230V/50Hz
Operating Mode	: AC charging + wireless charging mode

6.2.2 Block Diagram of Setup

The ESD test was performed in accordance with the EN 61000-4-2.





6.2.3 Test Result

Direct Discharge			Performance Criteria	
Discharge Level (kV)	Performance Criterion	Test Point	Contact Discharge	Air Discharge
$\pm 2 / \pm 4 / \pm 8$	TT	1	N/A	Pass*
$\pm 2 / \pm 4$	TT	2	Pass*	N/A

Remark:

Test points 1. All Exposed Surface & Seams; 2. All metallic part

* During the test no deviation was detected to the selected operation mode(s)

Indirect Discharge			Performance Criteria	
Discharge Level (kV)	Performance Criterion	Test Point	Horizontal Coupling	Vertical Coupling
$\pm 2 / \pm 4$	TT	1	Pass*	Pass*

Remark:

Test points 1. All sides

* During the test no deviation was detected to the selected operation mode(s)

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6.3 RF Electromagnetic Field (80MHz to 6 000MHz) (RS)

Test Requirement	ETSI EN 301 489-3
Test Method	ETSI EN 301 489-1, EN 61000-4-3
Face of EUT	Front, Back, Left, Right
Frequency Range	80MHz to 6 000MHz
Test Level	3V/m
Modulation	80%, 1kHz Amplitude Modulation.
Antenna polarisation	Horizontal& Vertical

6.3.1 E.U.T. Operation

Operating Environment:

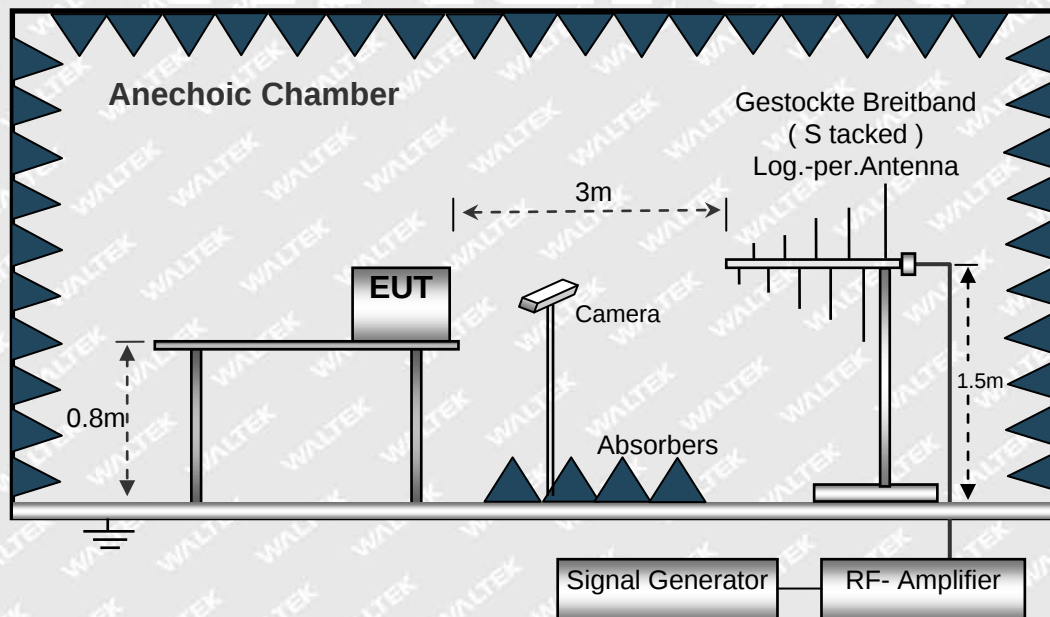
Temperature	22.1°C
Humidity	52.4%RH
Atmospheric Pressure	100.3kPa

EUT Operation:

Input Voltage	AC 230V/50Hz
Operating Mode	AC charging + wireless charging mode

6.3.2 Block Diagram of Setup

The Radiated Immunity test was performed in accordance with the EN 61000-4-3.





6.3.3 Test Result

Frequency	Face of EUT	Antenna polarisation	Test Level	Step Size	Dwell Time	Performance Criterion	Result
80MHz to 1000MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	CT	Pass*
80MHz to 1000MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	CT	Pass*
1000MHz to 6000MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	CT	Pass*
1000MHz to 6000MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	CT	Pass*

Remark:

* During the test no deviation was detected to the selected operation mode(s)

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6.4 Fast Transients Common Mode (EFT)

Test Requirement	: ETSI EN 301 489-3
Test Method	: ETSI EN 301 489-1, EN 61000-4-4
Polarity	: Positive & Negative
Repetition Frequency.....	: 5kHz
Burst Duration	: 300ms
Test Duration	: 2 minutes per level & polarity

6.4.1 E.U.T. Operation

Operating Environment:

Temperature.....	: 21.4°C
Humidity	: 51.7%RH
Atmospheric Pressure	: 100.2kPa

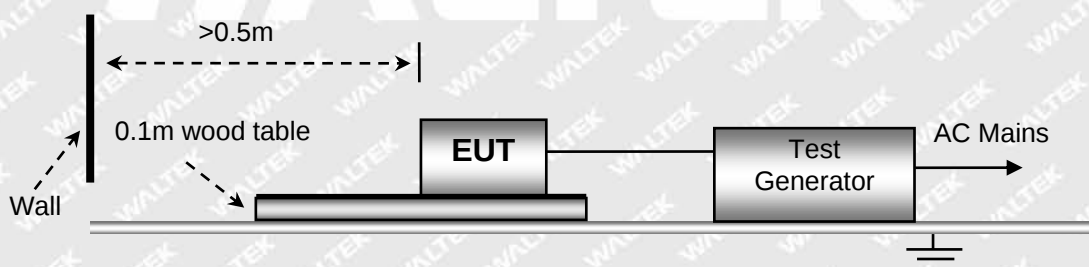
EUT Operation:

Input Voltage.....	: AC 230V/50Hz
Operating Mode	: AC charging + wireless charging mode

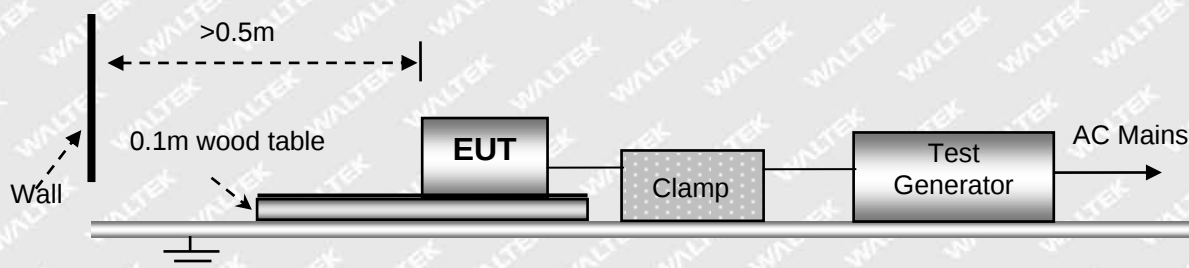
6.4.2 Block Diagram of Test Setup

The Electrical Fast Transients Immunity test was performed in accordance with the EN 61000-4-4.

For AC Mains or DC Ports:



For Signal, Wired network or Control Ports:





6.4.3 Test Result

Test Port	Test Level(kV)	Performance Criterion	Result
AC mains power port	±1.0	TT	Pass*
DC power port	±0.5	TT	N/A
Signal port	±0.5	TT	N/A
Control port	±0.5	TT	N/A
Wired network port	±0.5	TT	N/A

Remark:

* During the test no deviation was detected to the selected operation mode(s)

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6.5 Surges

Test Requirement	: ETSI EN 301 489-3
Test Method	: ETSI EN 301 489-1, EN 61000-4-5
Interval	: 60s between each surge
No. of surges	: 5 positive, 5 negative at 0°, 90°, 180°, 270°.

6.5.1 E.U.T. Operation

Operating Environment:

Temperature	: 22.1°C
Humidity	: 51.9%RH
Atmospheric Pressure	: 100.4kPa

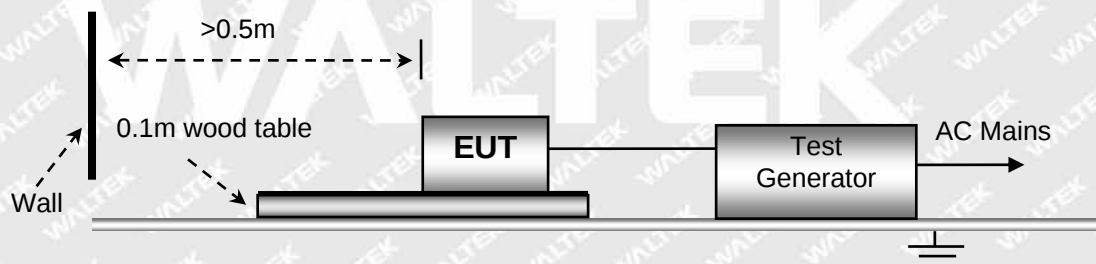
EUT Operation:

Input Voltage	: AC 230V/50Hz
Operating Mode	: AC charging + wireless charging mode

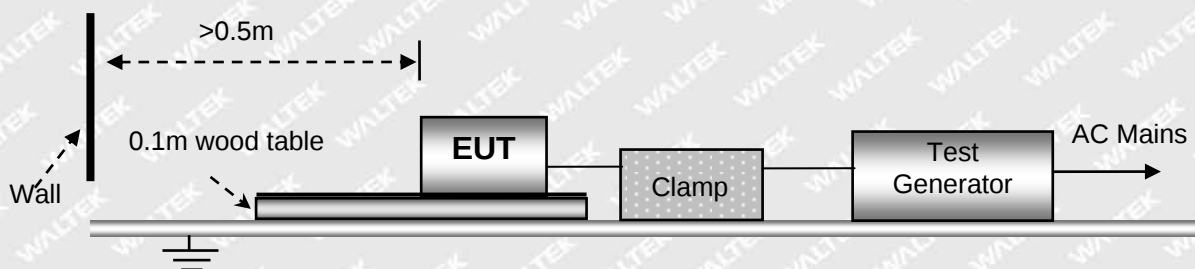
6.5.2 Block Diagram of Test Setup

The Surges Immunity test was performed in accordance with the EN 61000-4-5.

For AC Mains or DC Ports:



For Wired network port:





6.5.3 Test Result

Coupling point	Test Port	Applied Voltage (kV)	Performance criterion	Result
AC power port	Between Phase And Phase	±1	TT	N/A
	Between Live And Neutral	±1	TT	Pass*
	Between Live And Earth	±2	TT	N/A
	Between Neutral And Earth	±2	TT	N/A

Remark:

* During the test no deviation was detected to the selected operation mode(s)

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6.6 RF Common Mode 0,15 MHz to 80MHz (CS)

Test Requirement	: ETSI EN 301 489-3
Test Method	: ETSI EN 301 489-1, EN 61000-4-6
Frequency Range	: 150kHz to 80MHz
Test level	: 3V rms (unmodulated emf into 150 Ω)
Modulation	: 80%, 1kHz Amplitude Modulation.

6.6.1 E.U.T. Operation

Operating Environment:

Temperature	: 22.8°C
Humidity	: 52.4%RH
Atmospheric Pressure	: 100.1kPa

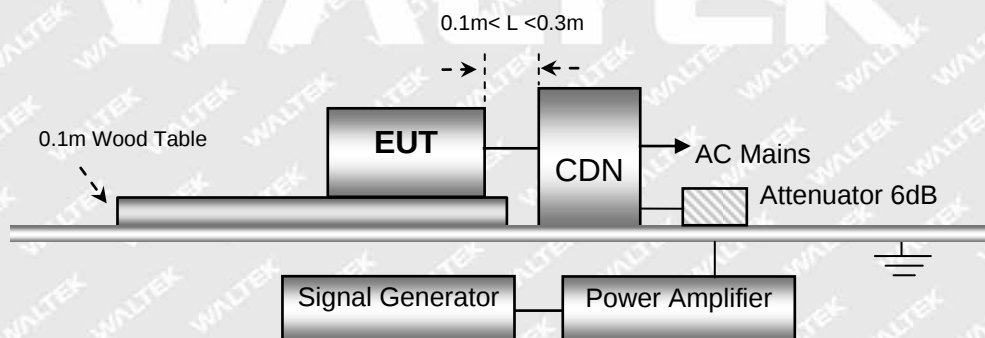
EUT Operation:

Input Voltage	: AC 230V/50Hz
Operating Mode	: AC charging + wireless charging mode

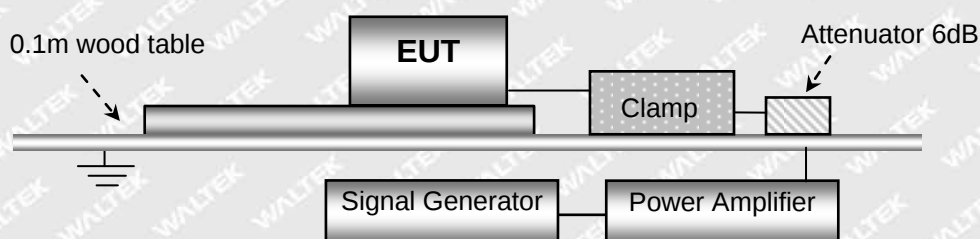
6.6.2 Block Diagram of Test Setup

The Injected Currents Immunity test was performed in accordance with the EN 61000-4-6.

For AC Mains or DC Ports:



For Signal, Wired network or Control Ports:





6.6.3 Test Result

Line	Voltage Level	Modulation	Step Size	Dwell Time	Performance Criteria	Test Result
AC mains power port	3Vr.m.s	80%, 1kHz Amp. Mod.	1%	1s	CT	Pass*
DC power port	3Vr.m.s	80%, 1kHz Amp. Mod.	1%	1s	CT	N/A
Signal port	3Vr.m.s	80%, 1kHz Amp. Mod.	1%	1s	CT	N/A
Wired network port	3Vr.m.s	80%, 1kHz Amp. Mod.	1%	1s	CT	N/A
Control port	3Vr.m.s	80%, 1kHz Amp. Mod.	1%	1s	CT	N/A

Remark:

* During the test no deviation was detected to the selected operation mode(s)

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6.7 Voltage Dips and Interruptions

Test Requirement : ETSI EN 301 489-3
Test Method : ETSI EN 301 489-1, EN 61000-4-11
No. of Dips / Interruptions : 3 per Level at 10ms intervals
Test Level(Voltage reduction) : 0%&70 % of U_T (Supply Voltage)

6.7.1 E.U.T. Operation

Operating Environment:

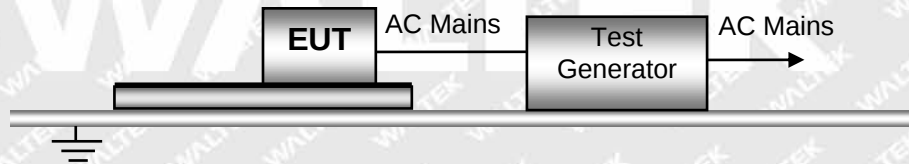
Temperature..... : 22.6°C
Humidity : 52.2%RH
Atmospheric Pressure : 100.5kPa

EUT Operation:

Input Voltage..... : AC 230V/50Hz
Operating Mode : AC charging + wireless charging mode

6.7.2 Block Diagram of Setup

The Voltage Dips and Interruptions Immunity test was performed in accordance with the EN 61000-4-11.



6.7.3 Test Result

Type	Test Level in % U_T	Phase	Duration	Performance criterion	Result
Voltage Dips	0	0° & 180°	0.5	TT	Pass*
	0	0° & 180°	1	TT	Pass*
	70	0° & 180°	25	TT	Pass*
Voltage Interruption	0	0° & 180°	250	TT	Pass*

Remark:

* During the test no deviation was detected to the selected operation mode(s)



7 Photographs - Test Setup

7.1 Photograph - Radiated Emissions Test Setup

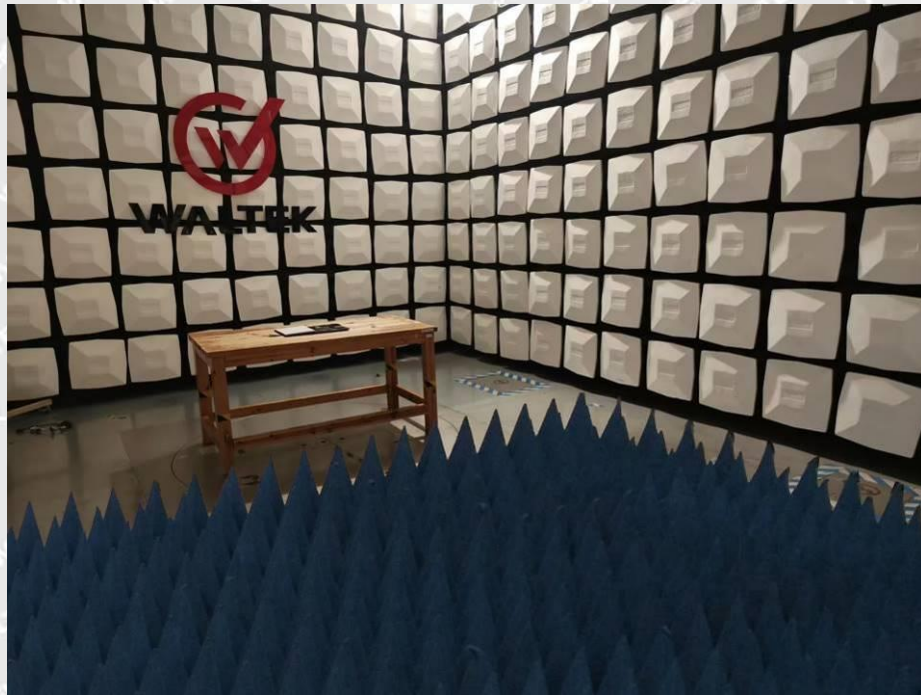


7.2 Photograph - Conducted Emissions Test Setup





7.3 Photograph - RF Electromagnetic Field Test Setup



7.4 Photograph - ESD Test Setup





7.5 Photograph - EFT Immunity Test Setup

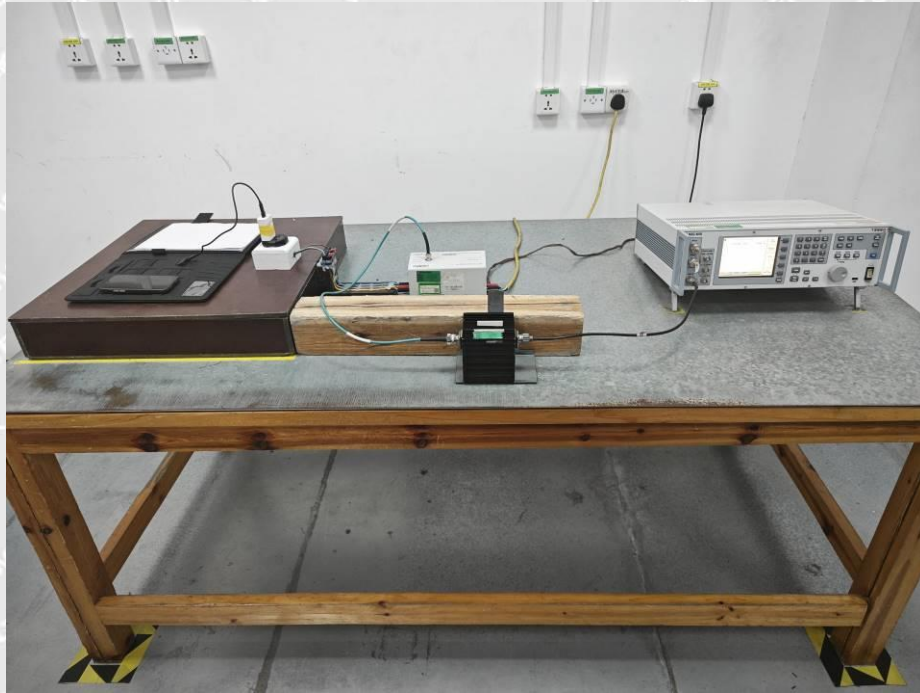


7.6 Photograph - Surge Immunity Test Setup





7.7 Photograph - Radio-frequency Common Mode Test Setup



7.8 Photograph - Voltage Dips and Interruptions Immunity Test Setup





8 Photographs – EUT Constructional Details

Please refer to “ANNEX”.

=====End of Report=====

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中国认可
国际互认
检测
TESTING
CNAS L6478



TEST REPORT

Reference No...... : WTF24F11263757W
Applicant..... : Mid Ocean Brands B.V.
Address..... : 7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong
Manufacturer : 111033
Address..... : ---
Product Name..... : A4 folder wireless power bank
Model No...... : MO2495
Test specification..... : EN 55032:2015+A11:2020+A1:2020
EN 55035:2017+A11:2020
Date of Receipt sample : 2024-12-17
Date of Test : 2024-12-17 to 2024-12-18
Date of Issue..... : 2024-12-27
Test Report Form No. : WEI-55032A-04B
Test Result..... : Pass

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

Prepared By:

Waltek Testing Group (Foshan) Co., Ltd.

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E-mail:info@waltek.com.cn

Tested by:

Roy Hong

Approved by:

Danny Zhou



1 Test Summary

EMISSION				
Test Item	Test Standard		Class / Severity	Result
Mains Terminal Disturbance Voltage, 150kHz to 30MHz	EN 55032:2015+A11:2020+A1:2020		Table A.10	Pass
Radiated Emission, 30MHz to 1000MHz	EN 55032:2015+A11:2020+A1:2020		Table A.4	Pass
Radiation Emission, 1GHz to 6GHz	EN 55032:2015+A11:2020+A1:2020		Table A.5	N/A
IMMUNITY (EN 55035:2017+A11:2020)				
Test Item	Test Method	Class / Severity	Performance Criteria	Result
Electrostatic Discharge(ESD)	IEC 61000-4-2:2008	±4 Kv Contact ±8 Kv Air	B	Pass
Continuous RF Electromagnetic Field Disturbances	IEC 61000-4-3: 2006+A1+A2	3V/m, 80%, 1kHz, Amp. Mod.	A	Pass
Electrical Fast Transients (EFT)	IEC 61000-4-4:2012	AC ±1.0Kv DC ±0.5Kv	B	Pass
Surge	IEC 61000-4-5:2005	±1Kv D.M.† ±2Kv C.M.‡	B	Pass
Continuous Induced RF Disturbances, 0.15MHz to 10MHz	IEC 61000-4-6:2008	3Vr.m.s.(emf), 80%, 1kHz Amp. Mod.	A	Pass
Continuous Induced RF Disturbances, 10MHz to 30MHz		3 to 1Vr.m.s.(emf), 80%, 1kHz Amp. Mod	A	
Continuous Induced RF Disturbances, 30MHz to 80MHz		1Vr.m.s.(emf), 80%, 1kHz Amp. Mod	A	
Power-Frequency Magnetic Field	IEC 61000-4-8:2009	1A/m	A	N/A
Voltage Dips	IEC 61000-4-11:2004	< 5 % U _T * for 0.5per	B	Pass
		70 % U _T * for 25/30per	C	
Voltage Interruptions			< 5 % U _T * for 250/300per	

Remark:

- Pass Test item meets the requirement
- Fail Test item does not meet the requirement
- N/A Test case does not apply to the test object
- A.M Amplitude Modulation
- † Differential Mode
- ‡ Common Mode
- * U_T is the nominal supply voltage



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3 General Information

3.1 General Description of E.U.T.

Product Name : A4 folder wireless power bank

Model No. : MO2495

Remark : ---

3.2 Details of E.U.T.

Technical Data : Type-C Input: DC 5V/3A, DC 9V/2A, DC 12V/1.5A
Type-C Output: DC 5V/3A, DC 9V/2A, DC 12V/1.5A
USB-A Output: DC 5V/3A, DC 9V/2A
Wireless output power: 15W Max.
Battery capacity: 3.7V, 5000mAh, 18.5Wh

3.3 Description of Support Units

The EUT has been tested as an independent unit. MO2495 is the test sample. The DV and RE tests were performed in the condition of AC 240V/50Hz input. The other tests were performed in the condition of AC 230V/50Hz input. The full tests were performed with the AC adapter specified by the laboratory. The RE, ESD and RS tests were performed in the additional condition of battery 3.7V input.

3.4 Standards Applicable for Testing

The tests were performed according to following standards:

EN 55032:2015+A11:2020 +A1:2020 Electromagnetic compatibility of multimedia equipment - Emission Requirements

EN 55035:2017+A11:2020 Electromagnetic compatibility of multimedia equipment - Immunity requirements



3.5 Test Facility

The test facility has a test site registered with the following organizations:

- **ISED – Registration No.: 21895**

Waltek Testing Group (Foshan) Co., Ltd. has been registered and fully described in a report filed with the Innovation, Science and Economic Development Canada (ISED). The acceptance letter from the ISED is maintained in our files. Registration ISED number: 21895, March 12, 2019

- **FCC – Registration No.: 820106**

Waltek Testing Group (Foshan) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 820106, August 16, 2018

- **NVLAP – Lab Code: 600191-0**

Waltek Testing Group (Foshan) Co., Ltd. EMC Laboratory is accredited by the National Voluntary Laboratory Accreditation Program (NVLAP/NIST). NVLAP Code: 600191-0.

This report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.

3.6 Subcontracted

Whether parts of tests for the product have been subcontracted to other labs:

☐ Yes ☒ No

If Yes, list the related test items and lab information:

Test items: ---

Lab information: ---

3.7 Abnormalities from Standard Conditions

None.



4 Equipment Used during Test

☐ Mains Terminal Disturbance Voltage (Conducted Emission) 1#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	EMI Test Receiver	R&S	ESR3	102423	Valid
2.	LISN	R&S	ENV216	101343	Valid
3.	Cable	HUBER+SUHNER	CBL2-NN-6M	223NN624	Valid
4.	Switch	CD	RSU-A4 18G	RSUA4008	Valid
☒ Mains Terminal Disturbance Voltage (Conducted Emission) 2#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	EMI Test Receiver	R&S	ESCI	101178	Valid
2.	LISN	R&S	ENV216	101215	Valid
3.	Cable	HUBER+SUHNER	CBL2-NN-6M	6102701	Valid
4.	Switch	ESE	RSU/M2	---	Valid
☐ Mains Terminal Disturbance Voltage (Conducted Emission) 3#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	EMI Test Receiver	R&S	ESR3	102842	Valid
2.	LISN	R&S	ENV216	101542	Valid
3.	Cable	YIHENG	LMR195UF-NMNM-2.5	---	Valid
4.	Manual RF Switch	YIHENG	SW-2	RSU0402	Valid
☐ Radiated Emission (30MHz to 1GHz) 1#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	3m Semi-anechoic Chamber	CHANGCHUANG	9m×6m×6m	-	Valid
2.	EMI Test Receiver	R&S	ESR7	101566	Valid
3.	Trilog Broadband Antenna	SCHWARZBECK	VULB 9162	9162-117	Valid
4.	Coaxial Cable (below 1GHz)	H+S	CBL3-NN-12+3 m	214NN320	Valid
☒ Radiated Emission (30MHz to 1GHz) 2#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	3m Semi-anechoic Chamber	YIHENG	9m×6m×6m	YH2021071801	Valid
2.	EMI Test Receiver	R&S	ESR7	102454	Valid
3.	Trilog Broadband Antenna	SCHWARZBECK	VULB 9163	01418	Valid
4.	Coaxial Cable (below 1GHz)	Times-Microwave Systems	LMR240UF-NMSM-7.5	-	Valid



☐ Radiated Emission (1GHz to 6GHz) 1#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	3m Semi-anechoic Chamber	CHANGCHUANG	9m×6m×6m	-	Valid
2.	EMI Test Receiver	R&S	ESR7	101566	Valid
3.	Broad-band Horn Antenna	SCHWARZBECK	BBHA 9120 D	01561	Valid
4.	Coaxial Cable (above 1GHz)	Times-Microwave	CBL5-NN	-	Valid
5.	Preamplifier	Lunar E M	LNA1G18-40	20160501002	Valid
☐ Radiated Emission (1GHz to 6GHz) 2#					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	3m Semi-anechoic Chamber	YIHENG	9m×6m×6m	YH2021071801	Valid
2.	EMI Test Receiver	R&S	ESR7	102454	Valid
3.	Broad-band Horn Antenna	SCHWARZBECK	BBHA9120D	02465	Valid
4.	Coaxial Cable (above 1GHz)	Times-Microwave Systems	SFT205-NMSM-7	-	Valid
5.	Preamplifier	Tonscend	TAP0118045	AP21J806168	Valid
☒ ESD					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	ESD Simulator	TESEQ	NSG437	521	Valid
☒ EFT & Voltage Dips and Interruptions					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	EMS test system	TESEQ	NSG3040	1858	Valid
☒ Surge					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	Surge Simulator	TESEQ	NSG3060	1395	Valid
☒ Injected Currents					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	Conducted Immunity test system	TESEQ	NSG4070	45345	Valid
2.	CDN	TESEQ	CDN M016	31586	Valid
3.	6dB Attenuator	TESEQ	ATN6075	32122	Valid



☒ Radio-frequency Electromagnetic Fields					
Item	Equipment	Manufacturer	Model No.	Serial No.	Calibration Status
1.	RF Power Amplifier	OPHIR	5225R	1051/1712	Valid
2.	RF Power Amplifier	OPHIR	5293RE	1051/171	Valid
3.	Stacked double logarithmic periodic antenna	SCHWARZBECK	STLP9128E-SPECIAL	142	Valid
4.	Stacked double logarithmic periodic antenna	SCHWARZBECK	STLP 9149	476	Valid
5.	Analog signal generator	RS	SMB100A	105566	Valid
6.	Power meter	RS	NRP6A	101133	Valid
7.	Power meter	RS	NRP6A	101134	Valid

☐: Not Used

☒: Used

4.1 Software List

Description	Manufacturer	Model	Version
EMI Test Software (Conducted Emission 1#)	FARATRONIC	EZ-EMC	EMEC-3A1
EMI Test Software (Conducted Emission 2#)	FARATRONIC	EZ-CON	FARAD-3A1.1+
EMI Test Software (Conducted Emission 3#)	FARATRONIC	EZ-EMC	EMC-CON 3A1.1+
EMI Test Software (Radiated Emission 1#)	FARATRONIC	EZ-EMC	RA-03A1-2
EMI Test Software (Radiated Emission 2#)	FARATRONIC	EZ-EMC	RA-03A1-2
Radiated Immunity Test Software	Chinese EMC	EMS	V1.0.0.0

4.2 Measurement Uncertainty

Test Item	Frequency Range	Uncertainty	Note
Conducted Emission	150kHz~30MHz	±2.6dB	(1)
Radiated Emission	30MHz~1GHz	±4.5dB	(1)
Radiated Emission	1GHz~6GHz	±4.5dB	(1)

(1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.



4.3 Special Accessories and Auxiliary Equipment

Item	Equipment	Technical Data	Manufacturer	Model No.
1.	AC Adapter	Input: 100-240V~, 50/60Hz, 0.5A Output: 5Vdc, 2.5A/9Vdc, 2A/12Vdc, 1.5A	Xiaomi	MDY-08-EH

4.4 Decision Rule

Compliance or non-compliance with a disturbance limit shall be determined in the following manner.

If U_{LAB} is less than or equal to U_{cispr} , then

- Compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- Non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

If U_{LAB} is greater than U_{cispr} , then

- Compliance is deemed to occur if no measured disturbance level, increased by $(U_{LAB} - U_{cispr})$, exceeds the disturbance limit;
- Non-compliance is deemed to occur if any measured disturbance level, increased by $(U_{LAB} - U_{cispr})$, exceeds the disturbance limit.

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5 Emission Test Results

5.1 Mains Terminals Disturbance Voltage, 150 kHz to 30MHz

Test Requirement	: EN 55032 Annex A.3
Test Method	: EN 55032 Annex A.3
Limit	: Table A.10 of EN 55032
Test Result	: Pass
Frequency Range	: 150kHz to 30MHz
Class	: Class B

5.1.1 E.U.T. Operation

Operating Environment:

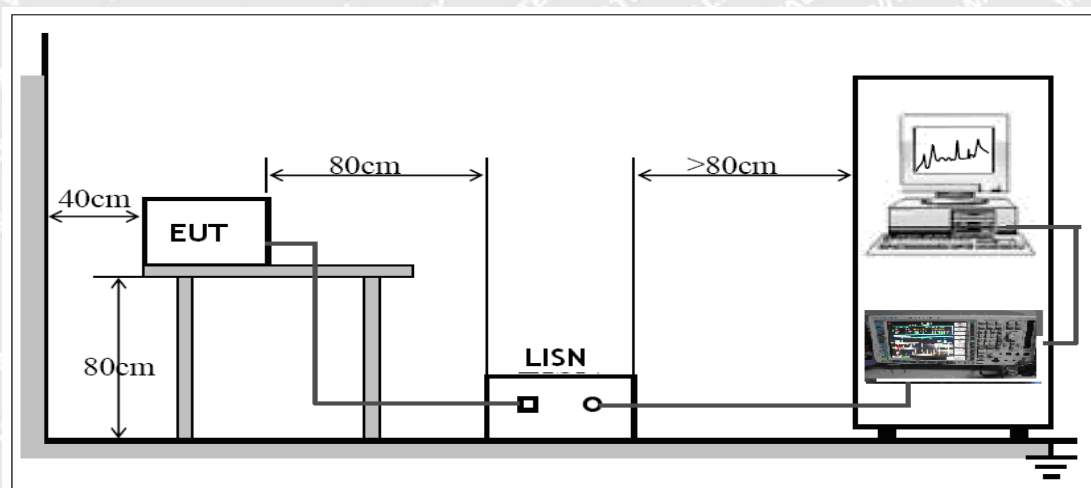
Temperature	: 20.8°C
Humidity	: 49.3%RH
Atmospheric Pressure	: 101.2kPa

EUT Operation:

Input Voltage	: AC 240V/50Hz
Operating Mode	: AC charging + wireless charging mode

5.1.2 Block Diagram of Test Setup

The Mains Terminals Disturbance Voltage tests were performed in accordance with the CISPR 16-1-2.



5.1.3 Measurement Data

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.



5.1.4 Corrected Amplitude & Margin Calculation

The Corrected factor is calculated by adding LISN VDF(Voltage Division Factor), Cable Loss and Transient Limiter Attenuation. The basic equation is as follows:

$$\text{Measurement} = \text{Reading Level} + \text{Correct Factor}$$

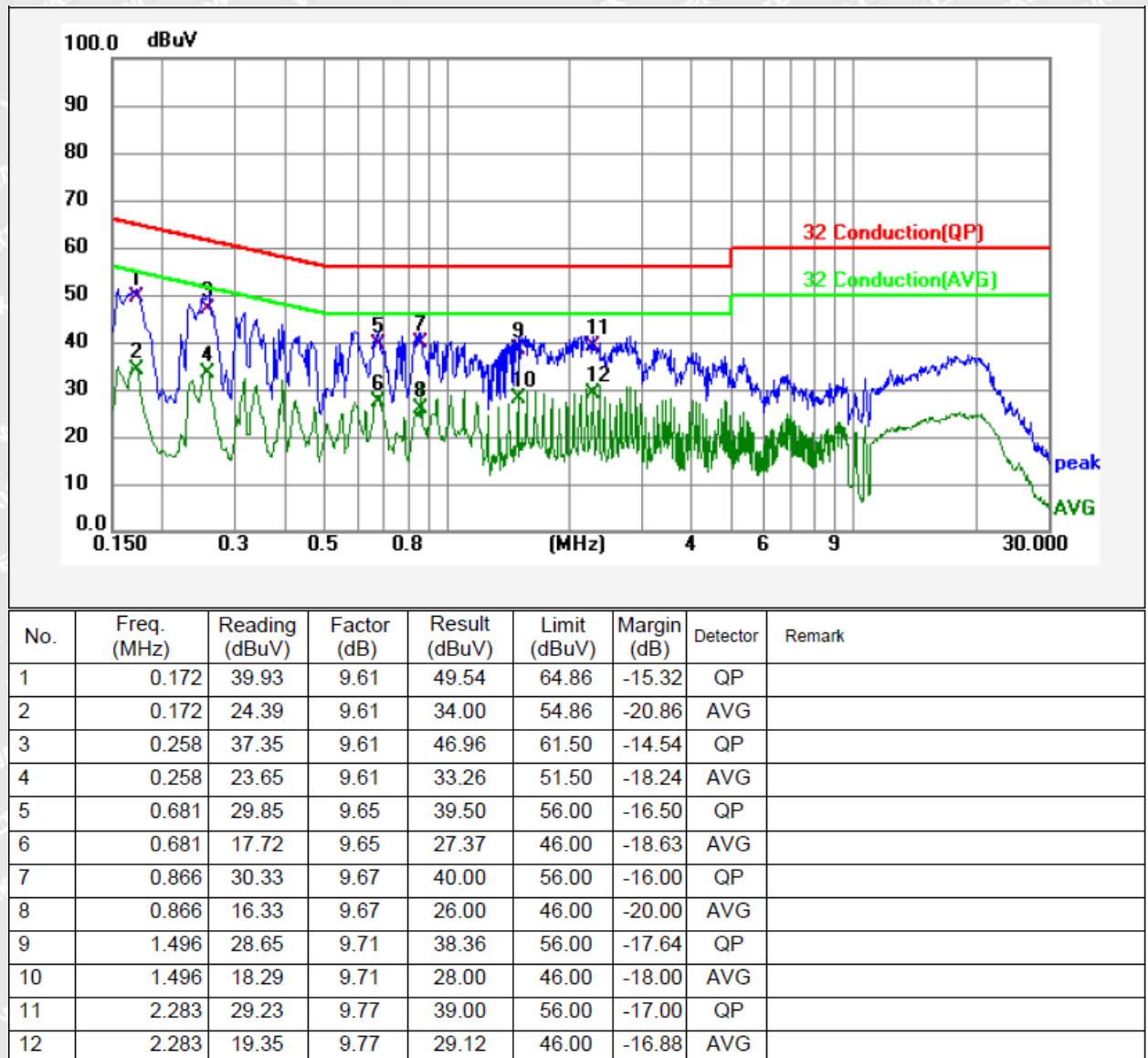
$$\text{Correct Factor} = \text{LISN VDF} + \text{Cable Loss}$$

The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Measurement} - \text{Limit}$$

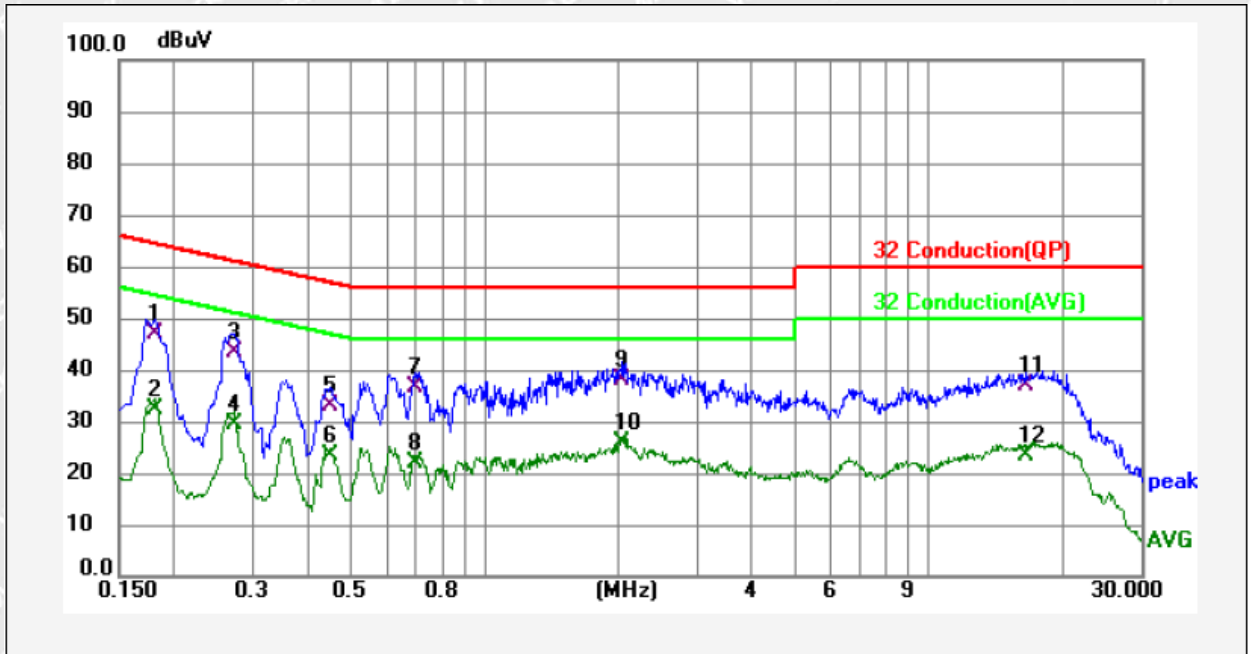
5.1.5 Mains Terminals Disturbance Voltage Test Data

Live Line





Neutral Line



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Margin (dB)	Detector	Remark
1	0.181	37.37	9.53	46.90	64.44	-17.54	QP	
2	0.181	22.89	9.53	32.42	54.44	-22.02	AVG	
3	0.272	33.82	9.54	43.36	61.06	-17.70	QP	
4	0.272	19.82	9.54	29.36	51.06	-21.70	AVG	
5	0.447	23.56	9.56	33.12	56.93	-23.81	QP	
6	0.447	14.00	9.56	23.56	46.93	-23.37	AVG	
7	0.695	27.11	9.58	36.69	56.00	-19.31	QP	
8	0.695	12.42	9.58	22.00	46.00	-24.00	AVG	
9	2.040	28.34	9.66	38.00	56.00	-18.00	QP	
10	2.040	16.34	9.66	26.00	46.00	-20.00	AVG	
11	16.651	26.76	10.24	37.00	60.00	-23.00	QP	
12	16.651	13.27	10.24	23.51	50.00	-26.49	AVG	



5.2 Radiated Emission, 30MHz to 1GHz

Test Requirement	: EN 55032 Annex A.2
Test Method	: EN 55032 Annex A.2
Test Limit.....	: Table A.4 of EN 55032
Test Result	: Pass
Frequency Range	: 30MHz to 1000MHz
Class	: Class B

5.2.1 E.U.T. Operation

Operating Environment:

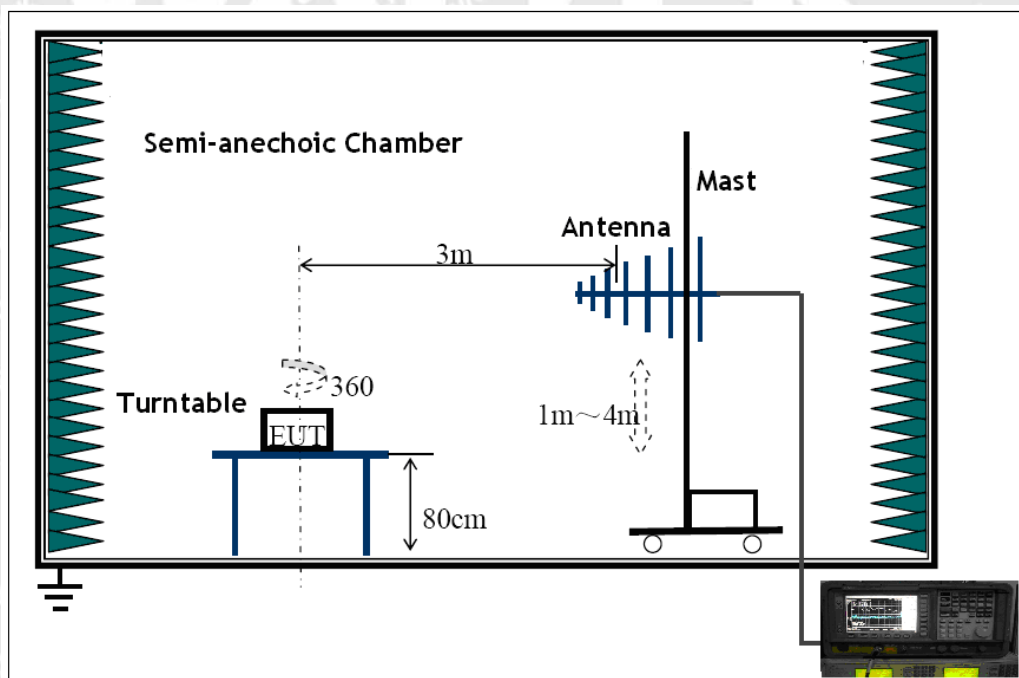
Temperature.....	: 23.6°C
Humidity	: 48.9%RH
Atmospheric Pressure	: 101.2kPa

EUT Operation:

Input Voltage.....	: AC 240V/50Hz for mode 1; Battery 3.7V for mode 2
Operating Mode	: Mode 1: AC charging + wireless charging mode Mode 2: Battery operated mode

5.2.2 Block Diagram of Test Setup

The Radiated Emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the CISPR 16-2-3.



5.2.3 Measurement Data

The maximised peak emissions from the EUT was scanned and measured for EUT 0°-360°. Quasi-peak measurements were performed if peak emissions were within 6dB of the limit line.



5.2.4 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Corr. Factor}$$

$$\text{Corr. Factor} = \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

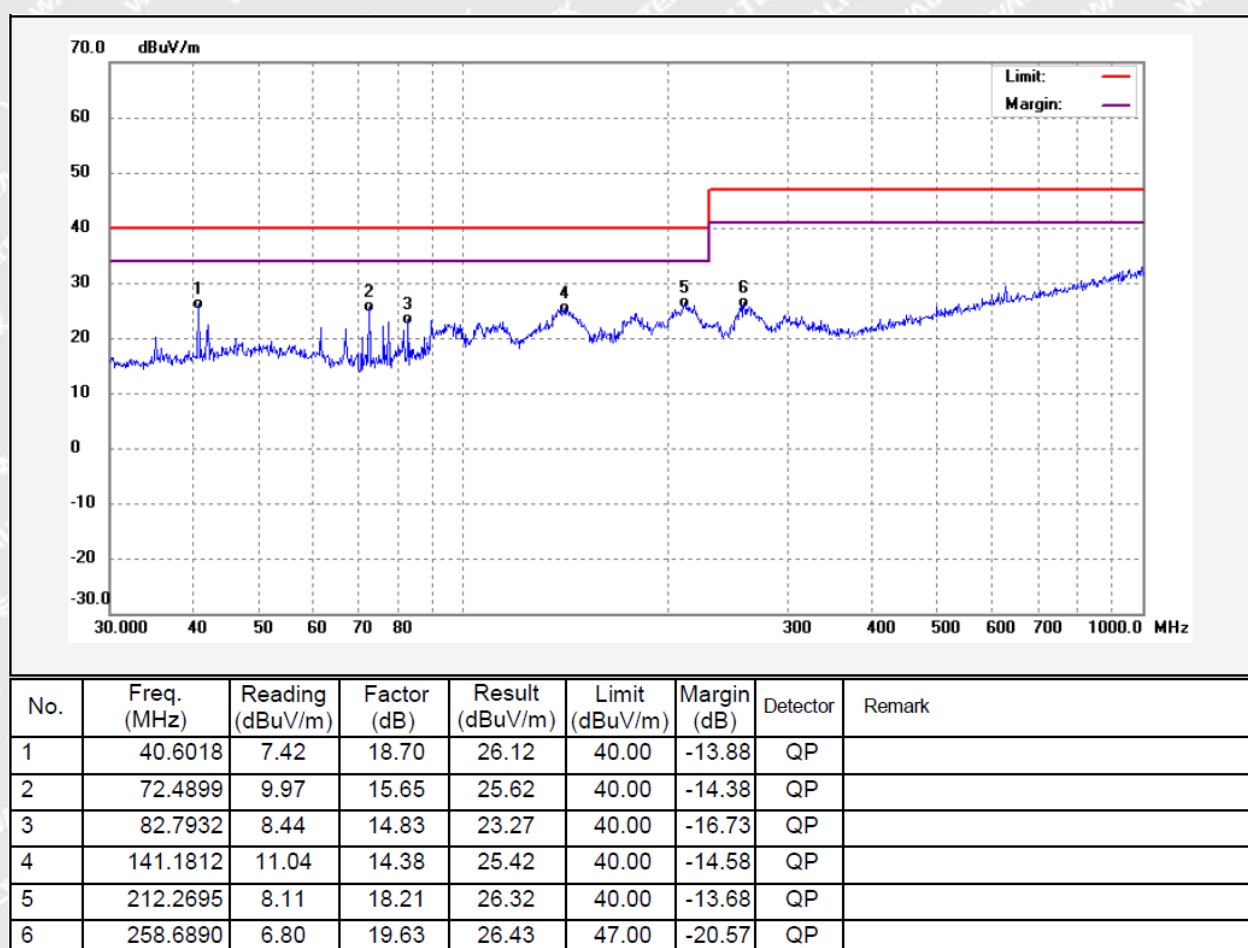
The "Margin" column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dB means the emission is 7dB below the maximum limit for Class B. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Corr. Ampl.} - \text{Limit}$$

5.2.5 Radiated Emission Test Data

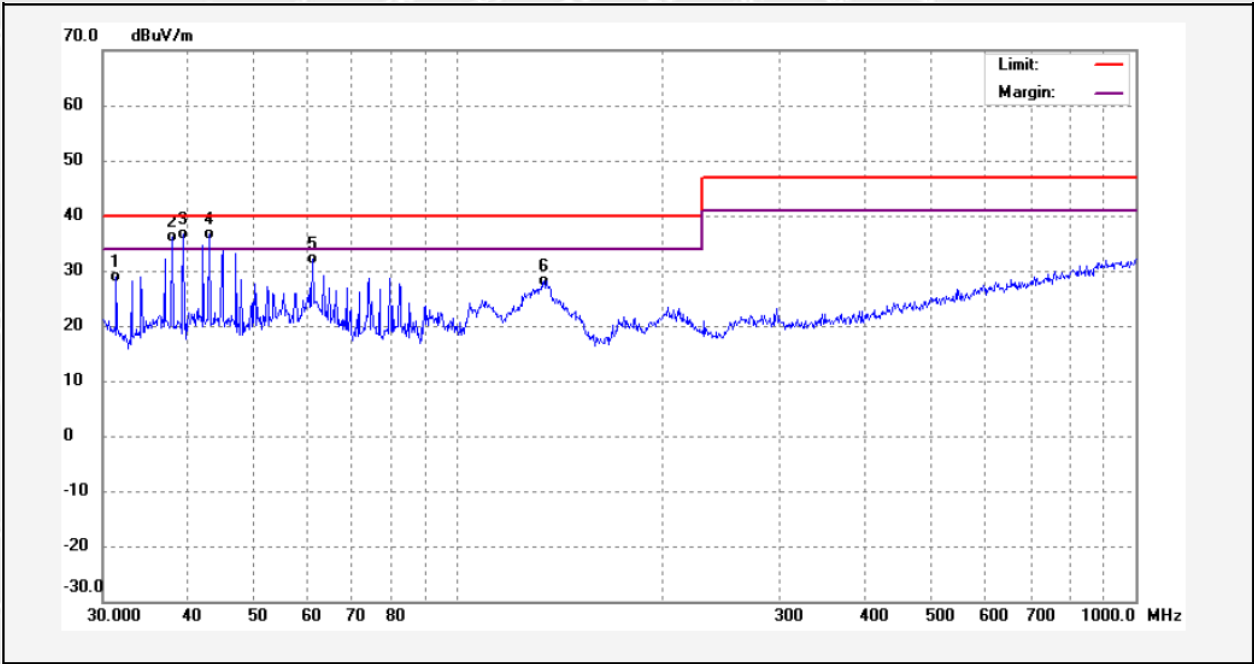
AC charging + wireless charging mode

Vertical Polarization





Horizontal Polarization

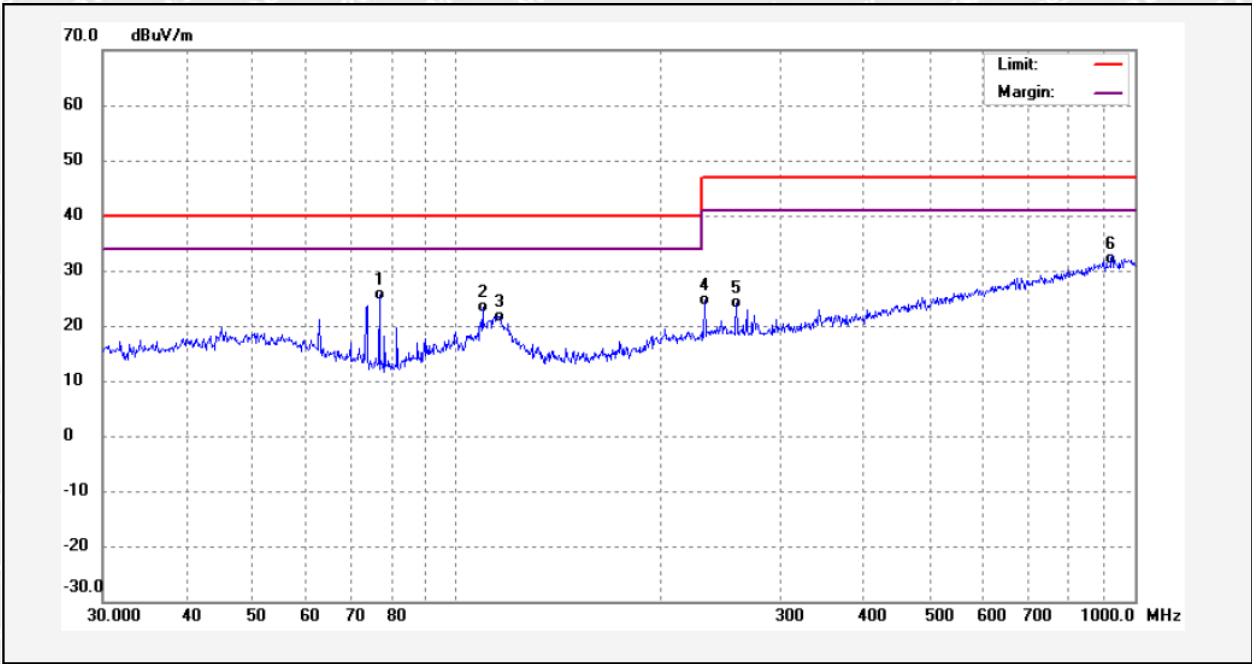


No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Remark
1	31.4433	12.12	16.79	28.91	40.00	-11.09	QP	
2	37.9539	17.96	18.16	36.12	40.00	-3.88	QP	
3	39.4480	18.14	18.47	36.61	40.00	-3.39	QP	
4	43.1260	17.53	19.22	36.75	40.00	-3.25	QP	
5	61.1745	13.86	18.17	32.03	40.00	-7.97	QP	
6	134.1822	13.40	14.62	28.02	40.00	-11.98	QP	



Battery operated mode

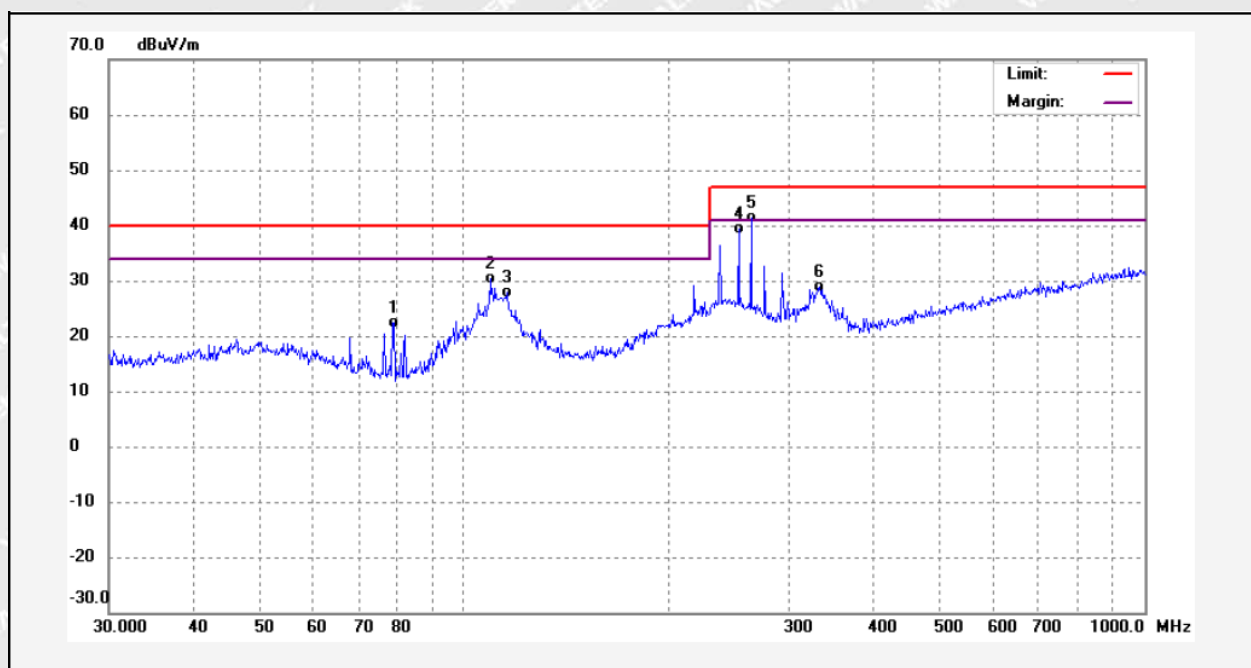
Vertical Polarization



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Remark
1	76.8078	10.92	14.61	25.53	40.00	-14.47	QP	
2	109.1434	5.19	18.16	23.35	40.00	-16.65	QP	
3	115.3610	4.39	17.34	21.73	40.00	-18.27	QP	
4	232.0431	6.00	18.72	24.72	47.00	-22.28	QP	
5	259.0521	4.38	19.65	24.03	47.00	-22.97	QP	
6	923.4867	1.72	30.42	32.14	47.00	-14.86	QP	



Horizontal Polarization



No.	Freq. (MHz)	Reading (dBuV/m)	Factor (dB)	Result (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	Remark
1	78.7164	8.21	14.13	22.34	40.00	-17.66	QP	
2	109.1817	12.35	18.15	30.50	40.00	-9.50	QP	
3	116.1321	10.50	17.28	27.78	40.00	-12.22	QP	
4	253.3920	19.93	19.52	39.45	47.00	-7.55	QP	
5	264.0967	21.57	19.76	41.33	47.00	-5.67	QP	
6	333.5698	7.28	21.50	28.78	47.00	-18.22	QP	



6 Immunity Test Results

6.1 Performance Criteria

Performance criterion A: The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

Performance criterion B: After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test

Performance criterion C: Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

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6.2 Electrostatic Discharge (ESD)

Test Requirement	: EN 55035
Test Method	: IEC 61000-4-2
Test Result	: Pass
Discharge Impedance	: 330Ω / 150pF
Discharge Voltage	Air Discharge: ±8kV Contact Discharge: ±4kV HCP & VCP: ±4kV
Polarity	: Positive & Negative
Number of Discharge	: Minimum 10 times at each test point
Discharge Mode	: Single Discharge
Discharge Period	: 1 second minimum

6.2.1 E.U.T. Operation

Operating Environment:

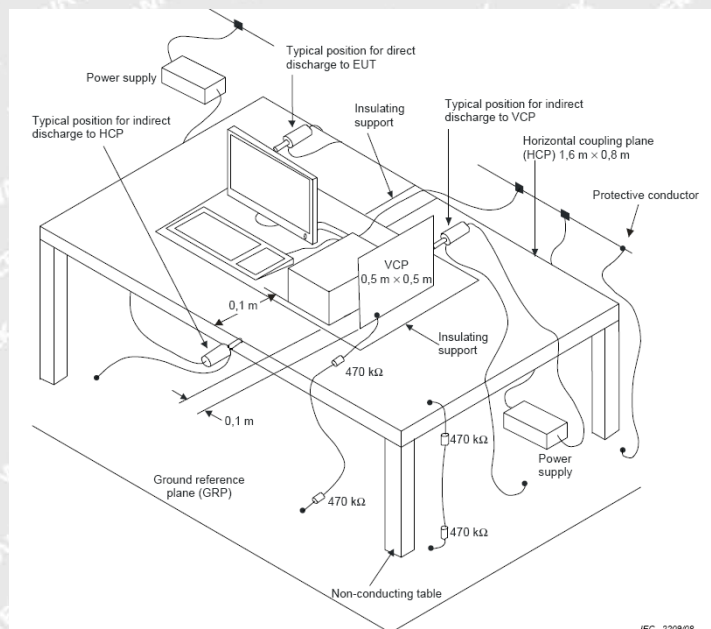
Temperature	: 23.1°C
Humidity	: 51.4%RH
Barometric Pressure	: 101.2kPa

EUT Operation:

Input Voltage	: AC 230V/50Hz for mode 1; Battery 3.7V for mode 2
Operating Mode	: Mode 1: AC charging + wireless charging mode Mode 2: Battery operated mode

6.2.2 Block Diagram of Setup

The ESD test was performed in accordance with the IEC 61000-4-2.





6.2.3 Direct Discharge Test Results

Observations:**Test points:**

1. All Exposed Surface & Seams;
2. All metallic part

Direct Discharge			Test Results	
Applied Voltage (kV)	Performance Criterion	Test Point	Contact Discharge	Air Discharge
±8	B	1	N/A	Pass*
±4	B	2	Pass*	N/A

Remark:

- * During the test no deviation was detected to the selected operation mode(s)

6.2.4 Indirect Discharge Test Results

Observations:**Test points:**

1. All sides.

Indirect Discharge			Test Results	
Applied Voltage (kV)	Performance Criterion	Test Point	Horizontal Coupling	Vertical Coupling
±4	B	1	Pass*	Pass*

Remark:

- * During the test no deviation was detected to the selected operation mode(s)



6.3 Continuous RF Electromagnetic Field Disturbances

Test Requirement	: EN 55035
Test Method	: IEC 61000-4-3
Test Result	: Pass
Frequency Range	: 80MHz to 1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz
Test level	: 3V/m
Modulation	: 80%, 1kHz Amplitude Modulation.
Face of EUT	: Front, Back, Left, Right
Antenna polarisation	: Horizontal & Vertical
Test Distance	: 3m

6.3.1E.U.T. Operation

Operating Environment:

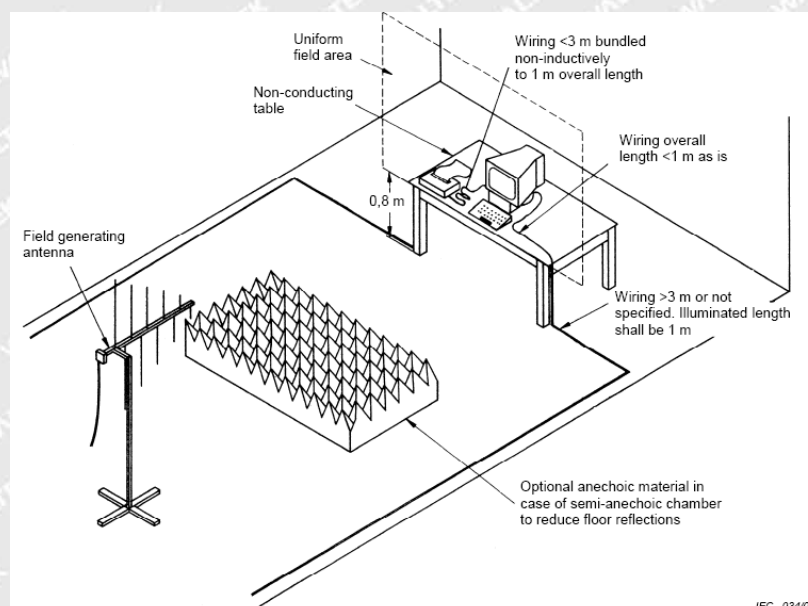
Temperature	: 23.1°C
Humidity	: 51.4%RH
Barometric Pressure	: 101.2kPa

EUT Operation:

Input Voltage	: AC 230V/50Hz for mode 1; Battery 3.7V for mode 2
Operating Mode	: Mode 1: AC charging + wireless charging mode Mode 2: Battery operated mode

6.3.2 Block Diagram of Setup

The Radio-frequency electromagnetic fields Immunity test was performed in accordance with the IEC 61000-4-3.



IEC 034/06



6.3.3 Test Results

Frequency	Face of EUT	Antenna polarisation	Test Level	Step Size	Dwell Time	Performance Criterion	Result
80 to 1000MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	A	Pass*
80 to 1000MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	A	Pass*
1800MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	A	Pass*
1800MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	A	Pass*
2600MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	A	Pass*
2600MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	A	Pass*
3500MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	A	Pass*
3500MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	A	Pass*
5000MHz	Front, Back, Left, Right	Horizontal	3V/m	1%	1s	A	Pass*
5000MHz	Front, Back, Left, Right	Vertical	3V/m	1%	1s	A	Pass*

Remark:

- * During the test no deviation was detected to the selected operation mode(s)



6.4 Electrical Fast Transients (EFT)

Test Requirement : EN 55035
Test Method : IEC 61000-4-4
Test Result : Pass
Test Level : 1.0kV on AC Mains
Polarity : Positive & Negative
Repetition Frequency : 5kHz
Burst Duration : 5/50ns
Test Duration : 2 minutes per level & polarity

6.4.1E.U.T. Operation

Operating Environment:

Temperature : 23.4°C
Humidity : 51.6%RH
Barometric Pressure : 101.3kPa

EUT Operation:

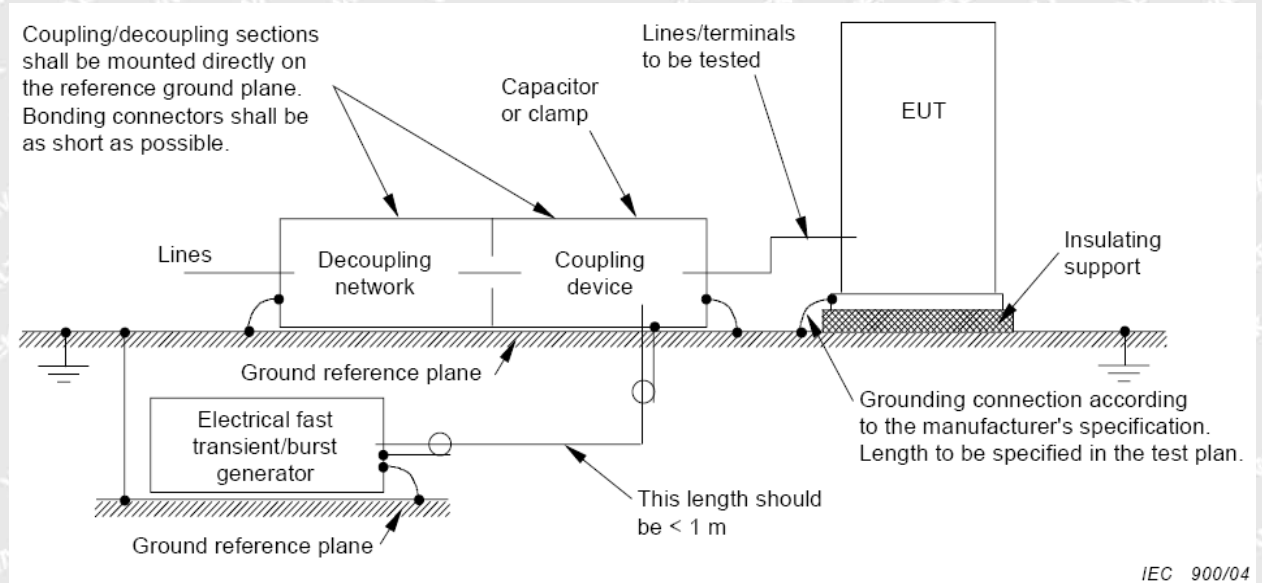
Input Voltage : AC 230V/50Hz
Operating Mode : AC charging + wireless charging mode

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6.4.2 Block Diagram of Setup

The Electrical Fast Transients Immunity test was performed in accordance with the IEC 61000-4-4.



6.4.3 Test Results

Test Port	Test Level(kV)	Performance Criterion	Result
Line-Neutral	± 1.0	B	Pass*

Remark:

* During the test no deviation was detected to the selected operation mode(s)



6.5 Surge

Test Requirement : EN 55035

Test Method : IEC 61000-4-5

Test Result : Pass

Test level : $\pm 1\text{kV}$ Live to Neutral, $\pm 2\text{kV}$ Live to PE and Neutral to PE

Interval : 60s between each surge

No. of surges : five positive and five negative pulses each at 0° , 90° , 180° and at 270°

6.5.1E.U.T. Operation

Operating Environment:

Temperature : 23.4°C

Humidity : 51.4%RH

Barometric Pressure : 101.4kPa

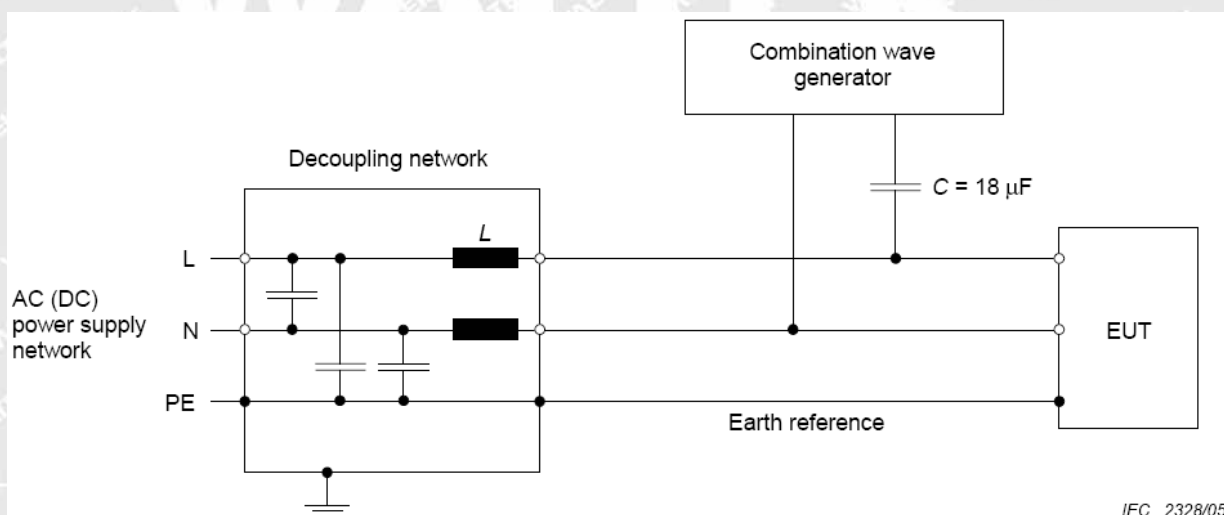
EUT Operation:

Input Voltage : AC 230V/50Hz

Operating Mode : AC charging + wireless charging mode

6.5.2Block Diagram of Setup

The Surge Immunity test was performed in accordance with the IEC 61000-4-5.





6.5.3 Test Result

Test Port	Applied Voltage (kV)	Performance criterion	Result
Between Phase And Phase	± 1	B	N/A
Between Live And Neutral	± 1	B	Pass*
Between Live And Earth	± 2	B	N/A
Between Neutral And Earth	± 2	B	N/A

Remark:

- * During the test no deviation was detected to the selected operation mode(s)

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6.6 Continuous Induced RF Disturbance

Test Requirement : EN 55035

Test Method : IEC 61000-4-6

Test Result : Pass

Frequency Range : 0.15 to 10MHz, 10 to 30MHz, 30 to 80MHz

Test level : 3V r.m.s. / 3~1V r.m.s. / 1V r.m.s. (unmodulated emf into 150 Ω)

Modulation : 80%, 1kHz Amplitude Modulation.

6.6.1E.U.T. Operation

Operating Environment:

Temperature : 23.4°C

Humidity : 51.6%RH

Barometric Pressure : 100.1kPa

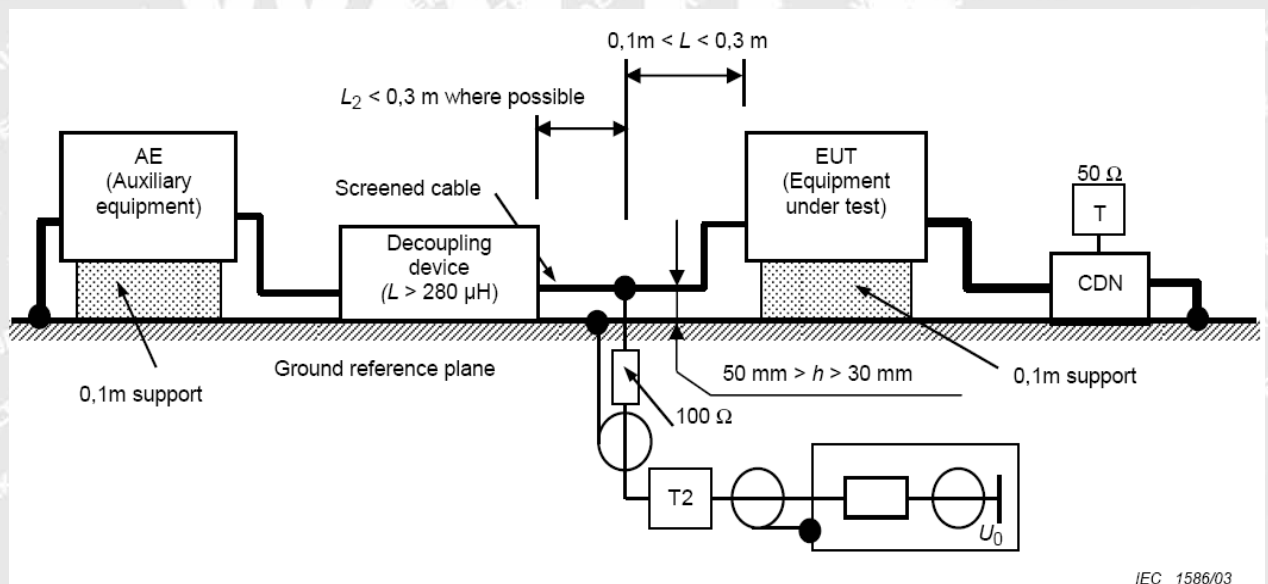
EUT Operation:

Input Voltage : AC 230V/50Hz

Operating Mode : AC charging + wireless charging mode

6.6.2 Block Diagram of Setup

The Injected Currents Immunity test was performed in accordance with the IEC 61000-4-6.





6.6.3Test Results

Frequency	Line	Test Level	Modulation	Step Size	Dwell Time	Performance Criterion	Result
0.15MHz to 10MHz	2 Wire AC Supply Cables	3Vr.m.s.	80%, 1kHz Amp. Mod.	1%	1s	A	Pass*
10MHz to 30MHz	2 Wire AC Supply Cables	3 to 1 Vr.m.s.	80%, 1kHz Amp. Mod.	1%	1s	A	Pass*
30MHz to 80MHz	2 Wire AC Supply Cables	1Vr.m.s.	80%, 1kHz Amp. Mod.	1%	1s	A	Pass*

Remark:

* During the test no deviation was detected to the selected operation mode(s)

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6.7 Voltage Dips and Interruptions

Test Requirement	: EN 55035
Test Method	: IEC 61000-4-11
Test Result	: Pass
Test Level(Voltage reduction)	: >90% & 30 % of Induction
No. of Dips / Interruptions	: 1 per Level at 20ms intervals

6.7.1E.U.T. Operation

Operating Environment:

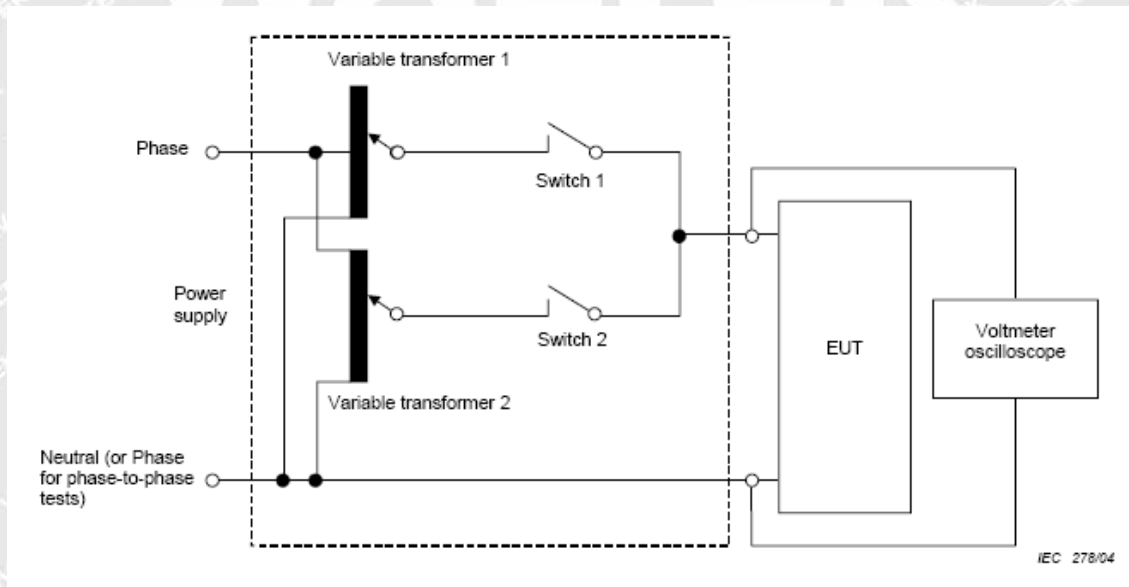
Temperature	: 23.5°C
Humidity	: 51.4%RH
Barometric Pressure	: 101.2kPa

EUT Operation:

Input Voltage	: AC 230V/50Hz
Operating Mode	: AC charging + wireless charging mode

6.7.2 Block Diagram of Setup

The Voltage Dips and Interruptions Immunity test was performed in accordance with the IEC 61000-4-11.





6.7.3Test Results

Test Item	Test Level in %U _T	Performance criterion	50Hz		60Hz	
			Duration	Result	Duration	Result
Voltage Dips	< 5	B	0.5	Pass*	0.5	Pass*
	70	C	25	Pass*	30	Pass*
Voltage Interruptions	< 5	C	250	Pass*	300	Pass*

Remark:

* During the test no deviation was detected to the selected operation mode(s)

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7 Photographs – Test Setup

7.1 Photograph – Mains Terminal Disturbance Voltage Test Setup



7.2 Photograph – Radiated Emission Test Setup, 30MHz to 1GHz

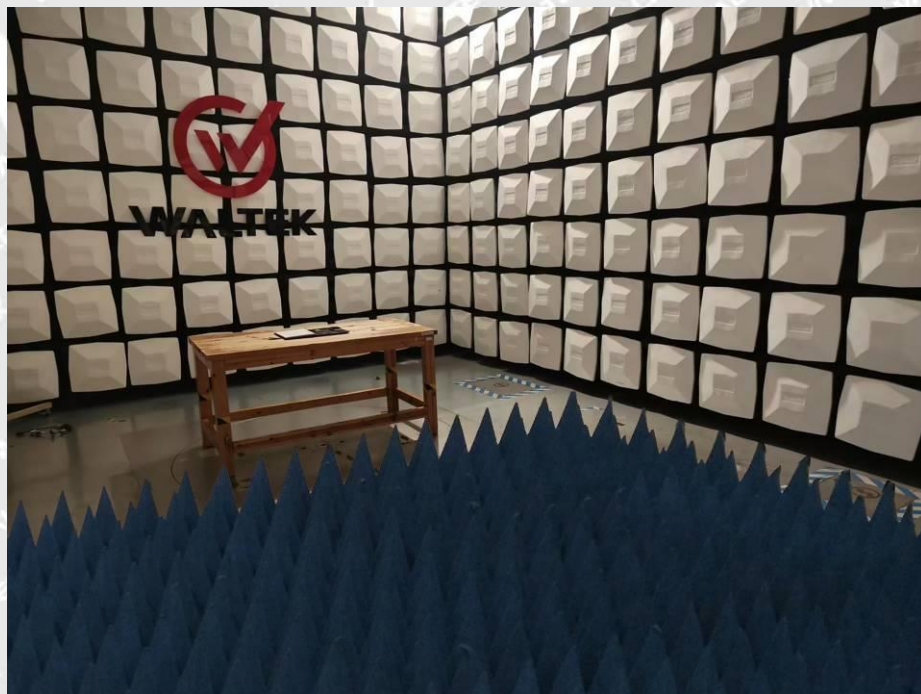




7.3 Photograph – ESD Immunity Test Setup



7.4 Photograph – Continuous RF Electromagnetic Field Disturbances Test Setup





7.5 Photograph – EFT Immunity Test Setup

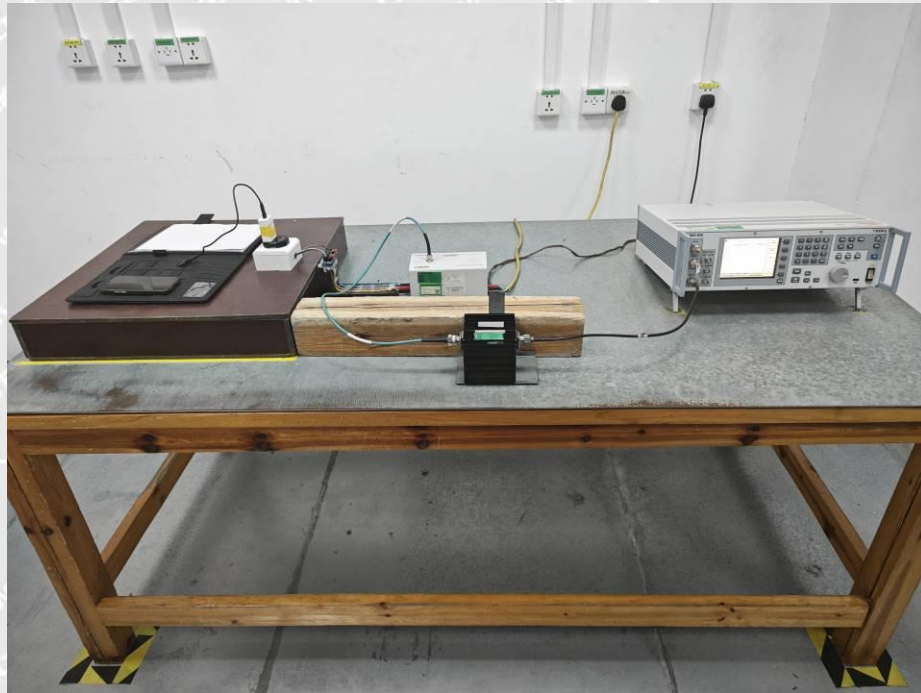


7.6 Photograph – Surge Immunity Test Setup





7.7 Photograph – Continuous Induced RF Disturbance Test Setup



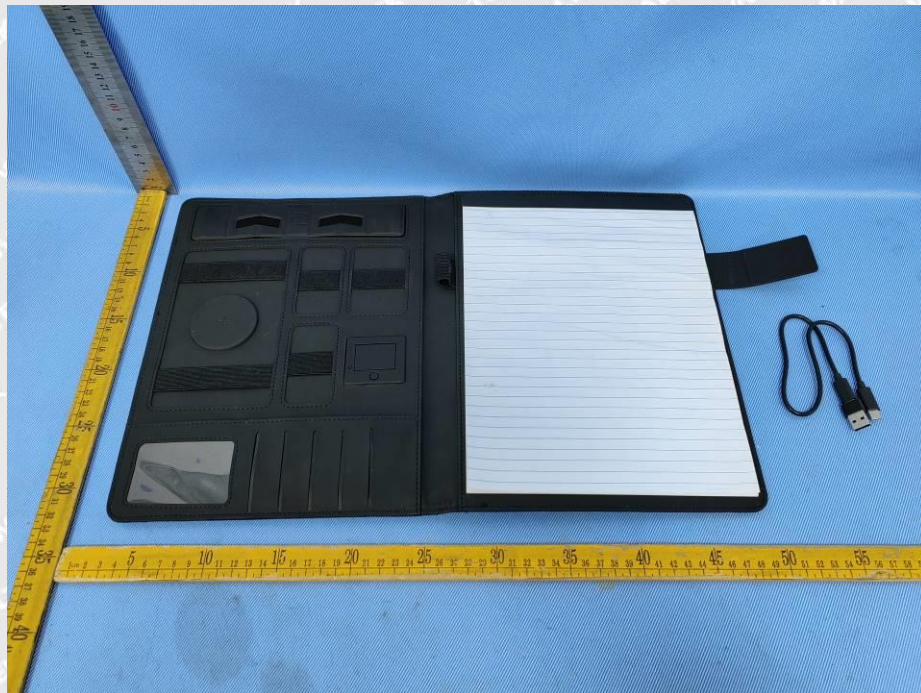
7.8 Photograph – Voltage Dips and Interruptions Immunity Test Setup

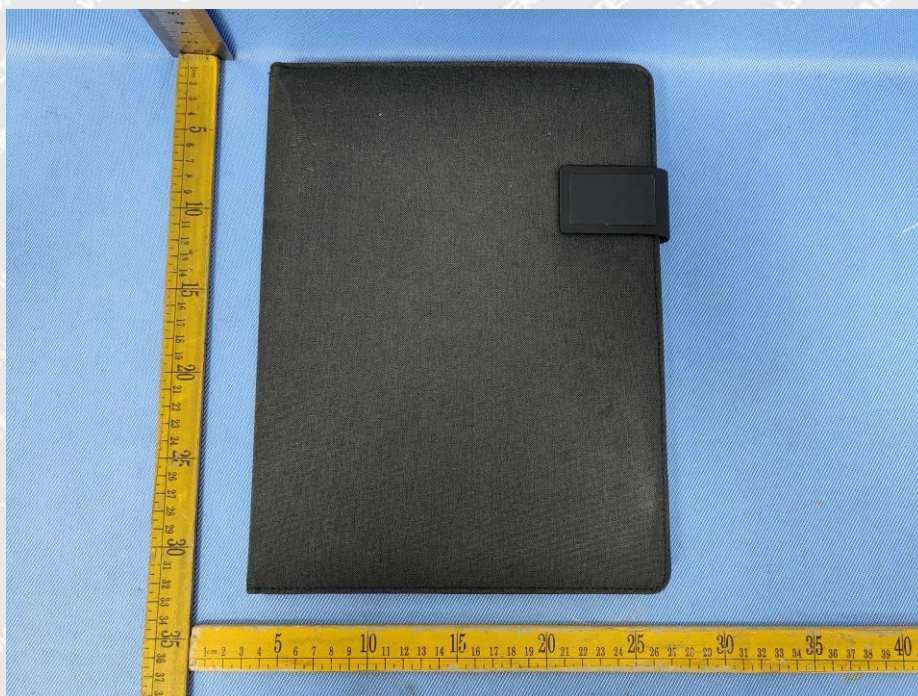




8 Photographs – Constructional Details

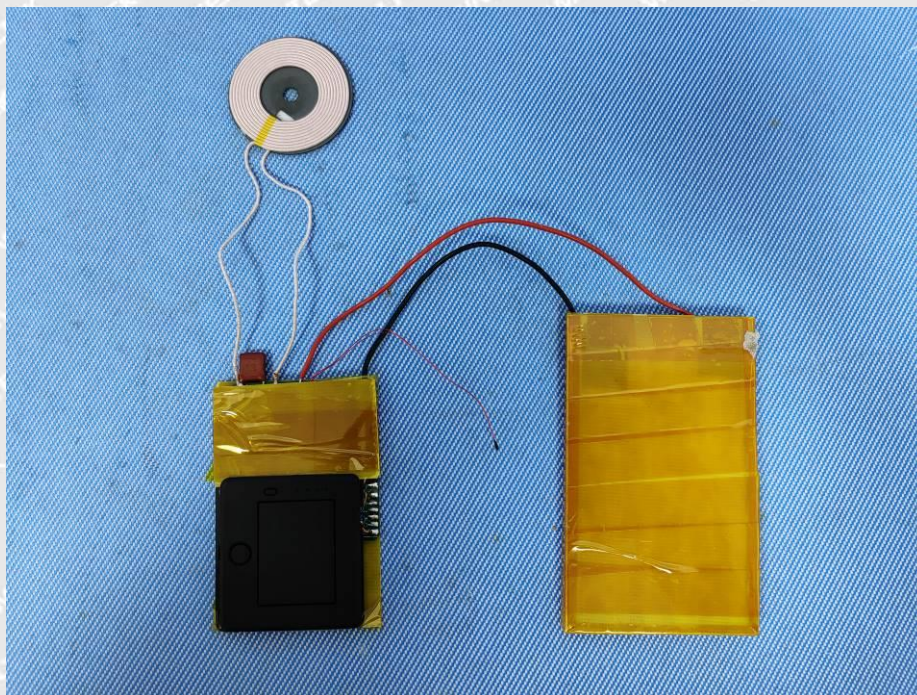
8.1 EUT – External Photos

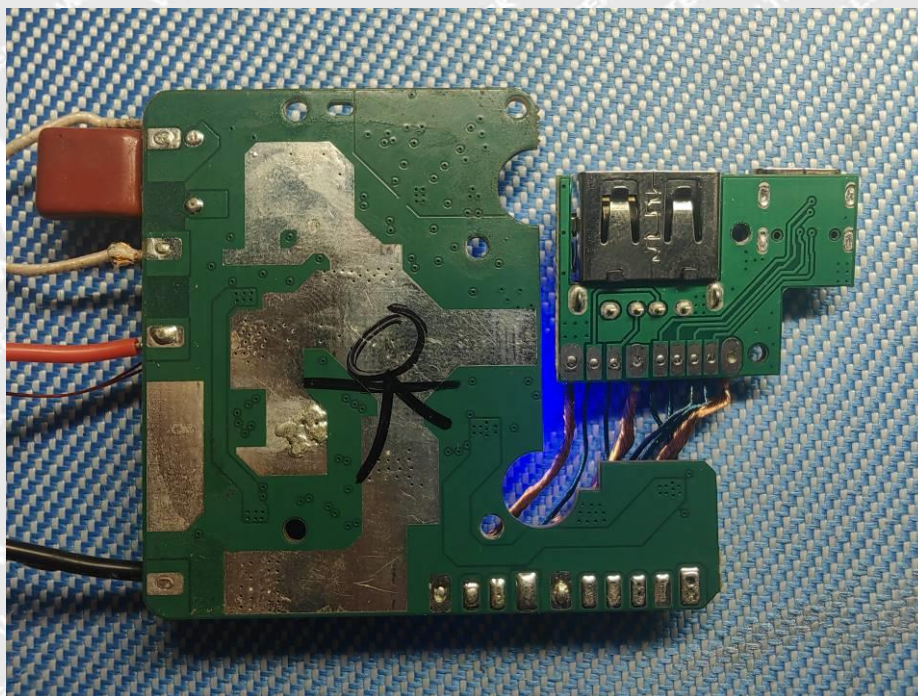
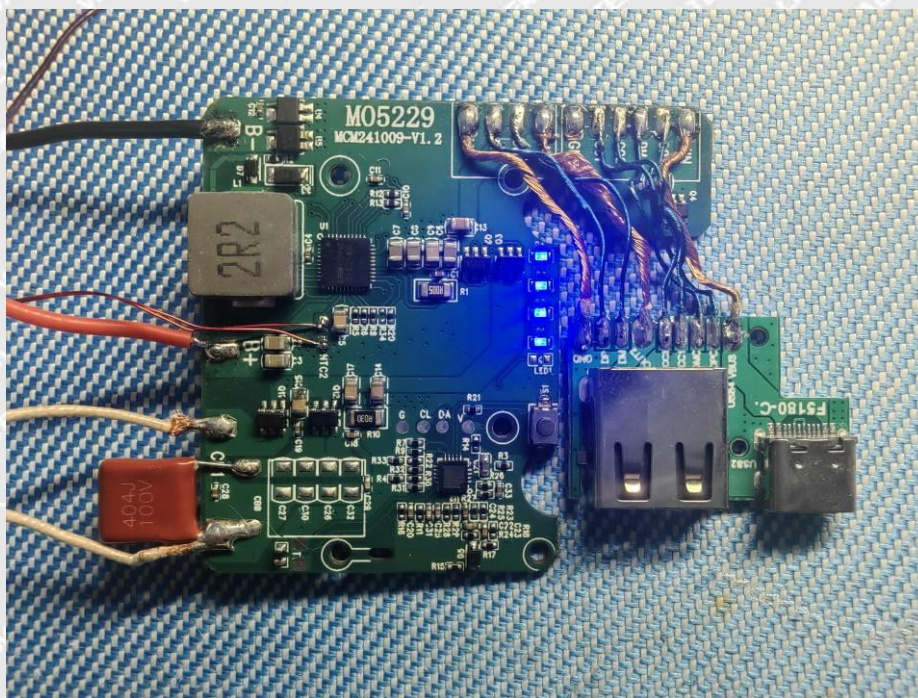






8.2 EUT – Internal Photos





===== End of Report =====